**MEASUREMENT REPORT****FCC Part 90****Applicant Name:**

Apple Inc.
One Apple Park Way
Cupertino, CA 95014
United States

Date of Testing:

05/05/2023 – 07/31/2023

Test Report Issue Date:

08/09/2023

Test Site/Location:

Element Materials Technology Morgan Hill, CA, USA

Test Report Serial No.:

1C2305020013-07.BCG

FCC ID:

BCG-A2984

APPLICANT:

Apple Inc.

Application Type:

Certification

Model:

A2984, A2985

EUT Type:

Watch

FCC Classification:

PCS Licensed Transmitter Worn on Body (PCT)

FCC Rule Part:

§2.1049, §90(S), §90(R)

Test Procedure(s):

ANSI C63.26-2015, TIA-603-E-2016, KDB 971168 D01 v03r01

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.



RJ Ortanez

Executive Vice President



FCC ID: BCG-A2984		PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 1 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

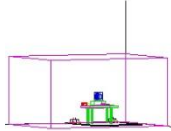
TABLE OF CONTENTS

1.0	INTRODUCTION	4
1.1	Scope	4
1.2	Element Materials Technology Test Location.....	4
1.3	Test Facility / Accreditations.....	4
2.0	PRODUCT INFORMATION.....	5
2.1	Equipment Description	5
2.2	Device Capabilities.....	5
2.3	Antenna Description	5
2.4	Test Support Equipment.....	7
2.5	Test Configuration	7
2.6	Software and Firmware	7
2.7	EMI Suppression Device(s)/Modifications	7
3.0	DESCRIPTION OF TESTS	8
3.1	Evaluation Procedure	8
3.2	Radiated Spurious Emissions	8
4.0	MEASUREMENT UNCERTAINTY	9
5.0	TEST EQUIPMENT CALIBRATION DATA	10
6.0	SAMPLE CALCULATIONS	11
7.0	TEST RESULTS.....	12
7.1	Summary.....	12
7.2	Occupied Bandwidth	14
7.3	Spurious and Harmonic Emissions at Antenna Terminal	21
7.4	Band Edge Emissions at Antenna Terminal	32
7.5	Conducted Power Output Data	42
7.6	Radiated Power (ERP)	44
7.7	Radiated Spurious Emissions	47
7.8	Frequency Stability / Temperature Variation	54
8.0	CONCLUSION.....	57

FCC ID: BCG-A2984		PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 2 of 57

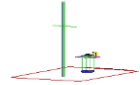
V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com



MEASUREMENT REPORT

FCC Part 90



Mode	Bandwidth	Modulation	Tx Frequency Range [MHz]	Measurement	OBW [MHz]	Max. Power [mW]	Max. Power [dBm]	Emission Designator
LTE Band 26	1.4 MHz	QPSK	814.7 - 823.3	Conducted	1.1051	354.813	25.50	1M11G7W
		16QAM	814.7 - 823.3	Conducted	1.1125	307.610	24.88	1M11D7W
	3 MHz	QPSK	815.5 - 822.5	Conducted	2.7448	354.813	25.50	2M74G7W
		16QAM	815.5 - 822.5	Conducted	2.7392	309.030	24.90	2M74D7W
	5 MHz	QPSK	816.5 - 821.5	Conducted	4.5554	354.813	25.50	4M56G7W
		16QAM	816.5 - 821.5	Conducted	4.5637	293.765	24.68	4M56D7W
	10 MHz	QPSK	819.0	Conducted	9.1438	354.813	25.50	9M14G7W
		16QAM	819.0	Conducted	5.4435	309.742	24.91	5M44D7W
LTE Band 14	5 MHz	QPSK	790.5 - 795.5	ERP	4.5708	0.305	-5.15	4M57G7W
		16QAM	790.5 - 795.5	ERP	4.5698	0.270	-5.68	4M57D7W
	10 MHz	QPSK	793.0	ERP	9.1089	0.294	-5.31	9M11G7W
		16QAM	793.0	ERP	5.4899	0.267	-5.74	5M49D7W

EUT Overview

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 3 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Innovation, Science and Economic Development Canada.

1.2 Element Materials Technology Test Location

These measurement tests were conducted at the Element facility located at 18855 Adams Court, Morgan Hill, CA 95037. The measurement facility is compliant with the test site requirements specified in ANSI C63.4-2014 and KDB 414788 D01 v01r01.

1.3 Test Facility / Accreditations

Measurements were performed at Element located in Morgan Hill, CA 95037, U.S.A.

- Element Materials Technology Morgan Hill is an ISO 17025-2017 accredited test facility under the American Association for Laboratory Accreditation (A2LA) with Certificate number 2041.02 for Specific Absorption Rate (SAR), Hearing Aid Compatibility (HAC) testing, where applicable, and Electromagnetic Compatibility (EMC) testing for FCC and Innovation, Science, and Economic Development Canada rules.
- Element Washington DC LLC TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC 17065-2012 by A2LA (Certificate number 2041.03) in all scopes of FCC Rules and ISED Standards (RSS).
- Element Materials Technology Morgan Hill facility is a registered (22831) test laboratory with the site description on file with ISED.
- Element Washington DC LLC is a Recognized U.S. Certification Assessment Body (CAB # US0110) for ISED Canada as designated by NIST under the U.S. and Canada Mutual Recognition Agreements (MRAs)

FCC ID: BCG-A2984		PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 4 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Apple Watch FCC ID: BCG-A2984**. The test data contained in this report pertains only to the emissions due to the EUT's licensed transmitters that operate under the provisions of Part 90.

Test Device Serial No.: HX7N0FC7G5,FK2V7143HC,CWXW2XN37F,X6VT27659F, FN6GW80015E00000M8

2.2 Device Capabilities

This device contains the following capabilities:

850/1700/1900 WCDMA/HSPA, Multi-band LTE, 802.11b/g/n WLAN, 802.11a/n UNII, 802.15.4 ab-NB, Bluetooth (1x, EDR, HDR4, HDR8, LE1M, LE2M), NFC, UWB, 60.5GHz Transmitter.

Simultaneous Tx Config	Antenna FCM					
	WLAN	Bluetooth	802.15.4ab-NB	LTE/WCDMA	UNII	UWB
	802.11b/g/n	BDR, EDR, HDR4/8, LE1/2M	OPSK	Mid/High Band	802.11a/n	Ch.5/Ch.9
Config 1	✓	✗	✗	✓	✗	✓
Config 2	✗	✓	✗	✓	✗	✓
Config 3	✗	✓	✓	✓	✗	✗
Config 4	✓	✗	✓	✓	✗	✗
Config 5	✗	✓	✗	✓	✓	✗
Config 6	✗	✓	✗	✓	✗	✓
Config 7	✓	✗	✗	✓	✗	✗
Config 8	✓	✗	✓	✗	✗	✗
Config 9	✓	✗	✗	✗	✗	✓
Config 10	✗	✓	✗	✗	✓	✗
Config 11	✗	✓	✗	✓	✗	✗
Config 12	✗	✓	✓	✗	✗	✗
Config 13	✗	✓	✗	✗	✗	✓
Config 14	✗	✗	✓	✓	✗	✗
Config 15	✗	✗	✗	✓	✓	✗
Config 16	✗	✗	✗	✓	✗	✓

Table 2-1. Simultaneous Transmission Configurations

✓ = Support; ✗ = Not Support

All the above simultaneous transmission configurations have been tested and the worst case configuration was found to be config 5 and reported in RF UNII, RF Bluetooth and RF Part 27b test reports.

2.3 Antenna Description

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 5 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

Following antenna gains provided by manufacturer were used for testing.

Band	Antenna Gain [dBi]
	Antenna BCM
LTE Band 26	-27.8
LTE Band 14	-28.5

Table 2-2. Highest Antenna Gain

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 6 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

2.4 Test Support Equipment

1	Apple Macbook	Model:	A1398	S/N:	FVFDHG8TP3XY
	w/AC/DC Adapter	Model:	A1435	S/N:	N/A
2	Apple USB-C cable	Model:	N/A	S/N:	N/A
	w/ Charging Dock	Model:	N/A	S/N:	DQ81346016Y08V221
	w/ Cradle	Model:	N/A	S/N:	CYV10420060A2LE03MP2C
3	Apple Magnetic Charger	Model:	A2515	S/N:	DLC217301Z91NR11B
	Apple Magnetic Charger	Model:	A2515	S/N:	DLC217301YM1NR112
4	Pathfinder Mocha X3100	Model:	920-13353-01	S/N:	DLCGMW0007D00000N7
	SiP Socket	Model:	P1 N20X B PF 307	S/N:	FN6GUA000JD00000M7
5	DC Power Supply	Model:	KPS3010D	S/N:	N/A
6	Store Sample Wristband	Model:	N/A	S/N:	DLC316300CU1QGKA2

Table 2-3. Test Support Equipment

2.5 Test Configuration

The EUT was tested per the guidance of ANSI C63.26 2015, TIA-603-E-2016 and KDB 971168 D01 v03r01. See Section 7.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

The worst case configuration was investigated for all combinations of various types of non-metal wristbands. The EUT was also investigated with and without wireless charger. The worst case configuration found was used for all testing.

For emissions from 1GHz – 18GHz, low, mid, and high channels were tested with highest power and worst case configuration. The emissions below 1GHz and above 18GHz were tested with the highest transmitting power and the worst case channel.

The EUT was manipulated through three orthogonal planes of X-orientation (flatbed), Y-orientation (landscape), and Z-orientation (portrait) during the testing. Only the worst case emissions were reported in this test report.

This device only supports 27RBs or less for 16-QAM uplink.

2.6 Software and Firmware

The test was conducted with firmware version watchOS 10.0 installed on the EUT.

2.7 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

FCC ID: BCG-A2984		PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 7 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

3.0 DESCRIPTION OF TESTS

3.1 Evaluation Procedure

The measurement procedures described in the document titled "Land Mobile FM or PM – Communications Equipment – Measurements and Performance Standards" (ANSI C63.26-2015 and TIA-603-E-2016) and "Procedures for Compliance Measurement of the Fundamental Emission Power of Licensed Wideband (> 1 MHz) Digital Transmission Systems" (KDB 971168 D01 v03r01) were used in the measurement of the EUT.

Deviation from Measurement Procedure.....None

3.2 Radiated Spurious Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Figure 5.7 of Clause 5 in ANSI C63.4-2014. Absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections for measurements above 1GHz. For measurements below 1GHz, the absorbers are removed. A raised turntable is used for radiated measurement. The turn table is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm tall test table made of Styrodur is placed on top of the turn table. A Styrodur pedestal is placed on top of the test table to bring the total table height to 1.5m.

The equipment under test was transmitting while connected to its integral antenna and is placed on a turntable 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer.

For radiated spurious emissions measurements and calculations, conversion method is used per the formulas in KDB 971168 Section 5.8.4. Field Strength (EIRP) is calculated using the following formulas:

$$E_{[\text{dB}\mu\text{V/m}]} = \text{Measured amplitude level}_{[\text{dBm}]} + 107 + \text{Cable Loss}_{[\text{dB}]} + \text{Antenna Factor}_{[\text{dB/m}]}$$

And

$$\text{EIRP}_{[\text{dBm}]} = E_{[\text{dB}\mu\text{V/m}]} + 20\log D - 104.8; \text{ where } D \text{ is the measurement distance in meters.}$$

All radiated measurements are performed in a chamber that meets the site requirements per ANSI C63.4-2014.

Per KDB 414788 D01 v01r01, radiated emission test sites other than open-field test sites (e.g., shielded anechoic chambers), may be employed for emission measurements below 30MHz if characterized so that the measurements correspond to those obtained at an open-field test site. To determine test site equivalency, a reference sample transmitting at 149kHz was measured on an open field test site (asphalt with no ground plane) and then measured in the 3m semi-anechoic chamber. A calibrated 60cm loop antenna was used while the reference device was rotated through the X, Y and Z axis in order to capture the worst case level. A maximum deviation of 2.77dB at 149kHz was measured when comparing the 3 meter semi-anechoic chamber to the open field site.

Radiated spurious emission levels are investigated with the receive antenna horizontally and vertically polarized per ANSI C63.26-2015 and TIA-603-E-2016.

FCC ID: BCG-A2984		PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 8 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

4.0 MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.23-2012. All measurement uncertainty values are shown with a coverage factor of $k = 2$ to indicate a 95% level of confidence. The measurement uncertainty shown below meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Contribution	Expanded Uncertainty ($\pm$ dB)
Conducted Bench Top Measurements	1.77
Radiated Disturbance (<30MHz)	4.38
Radiated Disturbance (30MHz-1GHz)	4.75
Radiated Disturbance (1-18GHz)	5.20
Radiated Disturbance (>18GHz)	4.72

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch
		Page 9 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST). Measurements antennas used during testing were calibrated in accordance to the requirements of ANSI C63.5-2017.

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent Technologies	N9030A	3Hz-44GHz PXA Signal Analyzer	6/21/2023	Annual	6/21/2024	MY49430244
ATM	180-442A-KF	20dB Nominal Gain Horn Antenna	11/1/2022	Annual	11/1/2023	T058701-01
ESPEC	SU-241	Tabletop Temperature Chamber	11/10/2022	Annual	11/10/2023	92009574
ETS-Lindgren	3117	Double Ridged Guide Antenna (1-18 GHz)	3/30/2023	Annual	3/30/2024	00218555
Keysight Technology	N9040B	UXA Signal Analyzer	3/10/2023	Annual	3/10/2024	MY57212015
Rohde & Schwarz	TS-PR18	Pre-Amplifier (1GHz - 18GHz)	6/2/2023	Annual	6/2/2024	100050
Rohde & Schwarz	FSV40	Signal Analyzer (10Hz-40GHz)	5/11/2023	Annual	5/11/2024	101619
Rohde & Schwarz	ESW44	EMI Test Receiver	6/6/2023	Annual	6/6/2024	101668
Rohde & Schwarz	TS-PR8	Pre-Amplifier (30MHz - 8GHz)	6/22/2023	Annual	6/22/2024	102356
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	10/13/2022	Annual	10/13/2023	161616
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	12/16/2022	Annual	12/16/2023	164715
Rohde & Schwarz	TS-PR1840	Pre-Amplifier (18GHz - 40GHz)	6/2/2023	Annual	6/2/2024	100050
Rohde & Schwarz	HFH2-Z2	Loop Antenna	5/1/2023	Annual	5/1/2024	100519
Rohde & Schwarz	ENV216	Two-Line V-Network	6/8/2023	Annual	6/8/2024	192052
Schwarzbeck	VULB 9162	Bilog Antenna (30MHz - 6GHz)	4/17/2023	Annual	4/17/2024	00304

Table 5-1. Test Equipment List

Notes:

- For equipment listed above that has a calibration date or calibration due date that falls within the test date range, care was taken to ensure that this equipment was used after the calibration date and before the calibration due date.

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 10 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

6.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7W

LTE BW = 8.62 MHz

G = Phase Modulation

7 = Quantized/Digital Info

W = Combination of Any

16QAM Modulation

Emission Designator = 8M45D7W

LTE BW = 8.45 MHz

D = Amplitude/Angle Modulated

7 = Quantized/Digital Info

W = Combination of Any

Spurious Radiated Emission

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was -81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of -81.0 dBm on the spectrum analyzer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of -30.9 dBm yielding -24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm - (-24.80).

FCC ID: BCG-A2984		PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 11 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

7.0 TEST RESULTS

7.1 Summary

Company Name: Apple Inc.
 FCC ID: BCG-A2984
 FCC Classification: PCS Licensed Transmitter Worn on Body (PCT)
 Mode(s): LTE

Test Condition	Test Description	FCC Part Section(s)	Test Limit	Test Result	Reference
CONDUCTED	Occupied Bandwidth	2.1049	N/A	N/A	Section 7.2
	Conducted Band Edge / Spurious Emissions (LTE Band 14)	2.1051, 90.543(e)	On all frequencies between 769-775 MHz and 799-805 MHz, attenuation by a factor not less than $65 + 10 \log(P)$ dB in a 6.25 kHz band segment, for mobile and portable stations. On any frequency between 775-788 MHz, above 805 MHz, and below 758 MHz, attenuation by at least $43 + 10 \log(P)$ dB	PASS	Sections 7.3, 7.4
	Conducted Band Edge / Spurious Emissions (LTE Band 26)	2.1051, 90.691(a)	-13 dBm for all out-of-band emissions except -30 dBm at Band Edge and for all out-of-band emissions within 37.5kHz of Block Edge	PASS	Sections 7.3, 7.4
	Frequency Stability (LTE Band 14)	2.1055	Fundamental emissions stay within authorized frequency block over the temperature and voltage range as tested.	PASS	Section 7.8
	Frequency Stability (LTE Band 26)	90.213	< 2.5 ppm	PASS	Section 7.8
	Conducted Power	2.1046, 90.635	< 100 Watts	PASS	Section 7.5
	Effective Radiated Power (LTE Band 14)	90.542(a)(7)	< 3 Watts max. ERP	PASS	Section 7.6
RADIATED	Radiated Spurious Emissions (LTE Band 14)	2.1053, 90.543(e)	> $43 + 10 \log_{10}(P[\text{Watts}])$ for all out-of-band emissions except emissions in the 1559 - 1610MHz band are subject to a limit of -40dBm/MHz for wideband signals	PASS	Section 7.7
	Radiated Spurious Emissions (LTE Band 26)	2.1053, 90.691(a)	-13 dBm for all out-of-band emissions except -30 dBm at Band Edge and for all out-of-band emissions within 37.5kHz of Block Edge	PASS	Section 7.7

Table 7-1. Summary of Test Results

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 12 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

Notes:

1. All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
2. The analyzer plots shown in Section 7.0 were taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
3. All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
4. For conducted spurious emissions, automated test software was used to measure emissions and capture the corresponding plots necessary to show compliance. The measurement software utilized is Element EMC Software Tool v1.1.

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 13 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

7.1.1 Occupied Bandwidth

§2.1049

Test Overview

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. All modes of operation and all ports were investigated and the worst case configuration results are reported in this section.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 4.2

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW $\geq 3 \times$ RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

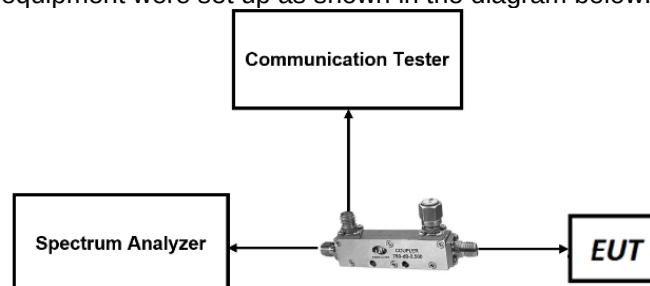


Figure 7-1. Test Instrument & Measurement Setup

Test Notes

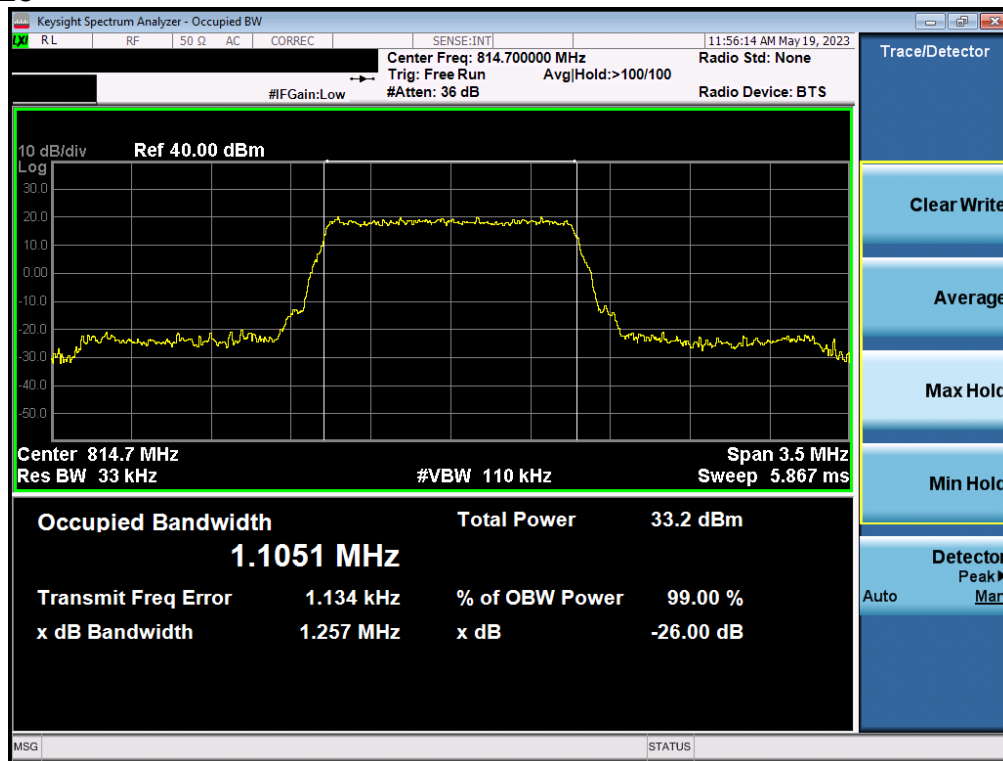
None.

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 14 of 57

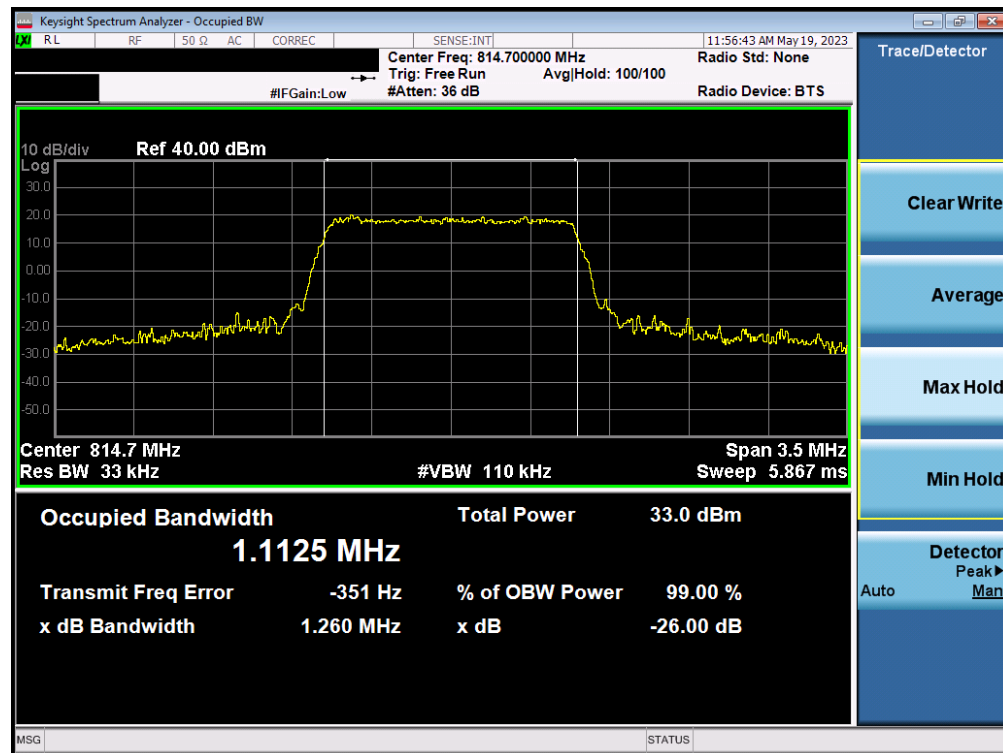
V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

LTE Band 26



Plot 7-1. Occupied Bandwidth Plot (LTE Band 26 - 1.4MHz QPSK - Full RB Configuration)

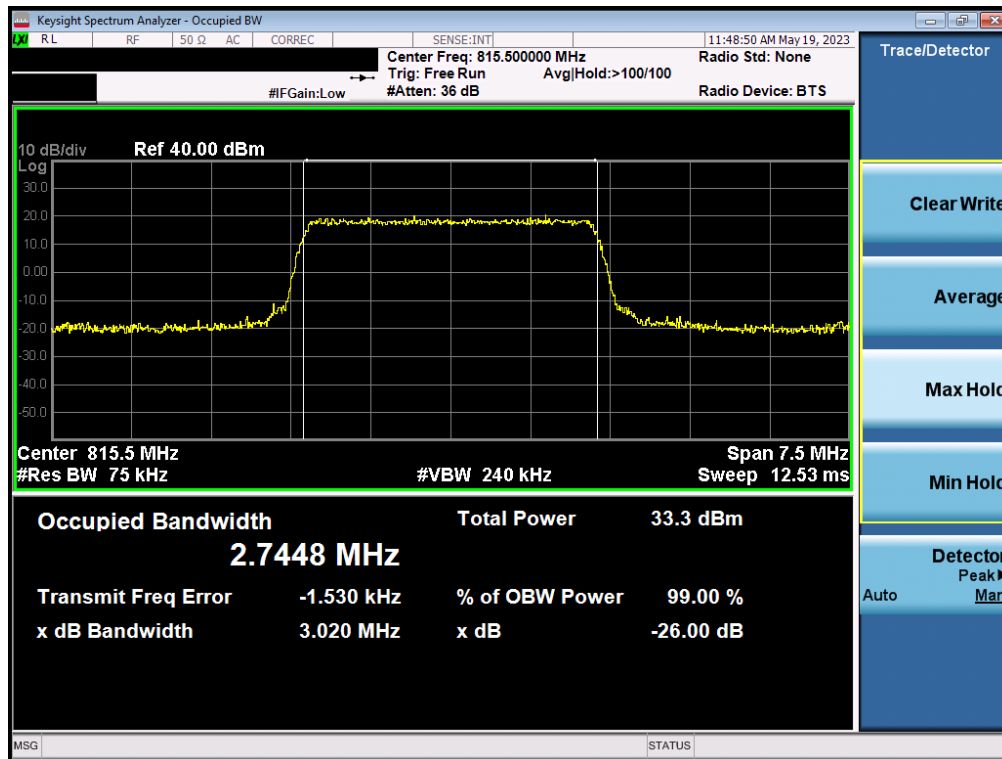


Plot 7-2. Occupied Bandwidth Plot (LTE Band 26 - 1.4MHz 16-QAM - Full RB Configuration)

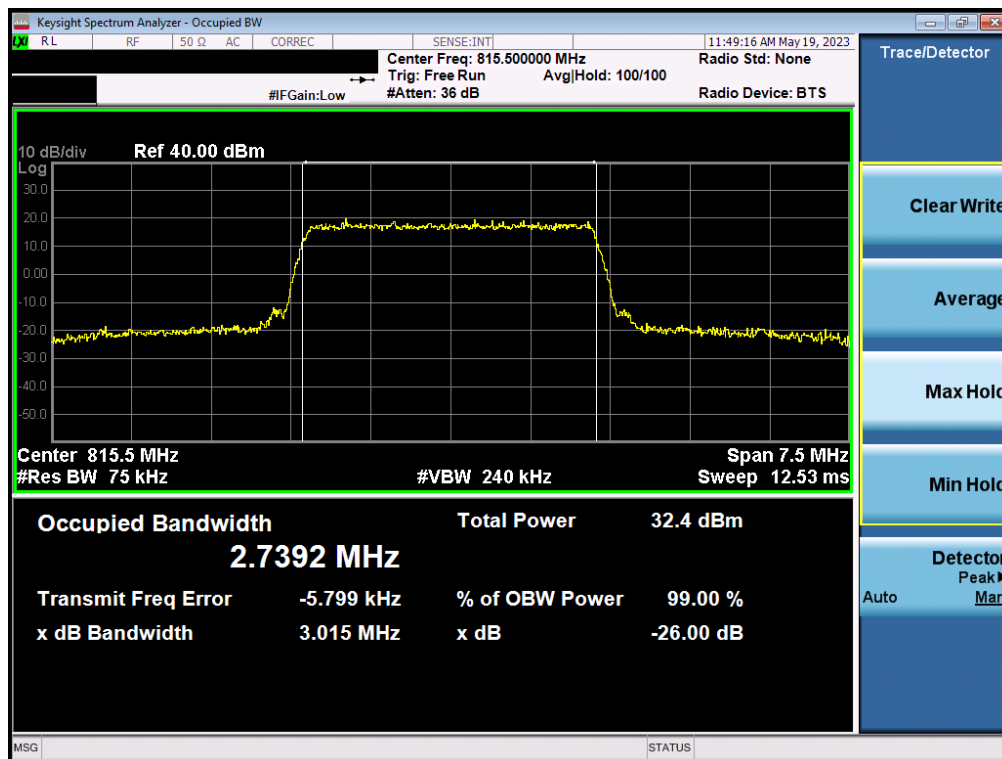
FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 15 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com



Plot 7-3. Occupied Bandwidth Plot (LTE Band 26 - 3MHz QPSK - Full RB Configuration)



Plot 7-4. Occupied Bandwidth Plot (LTE Band 26 - 3MHz 16-QAM - Full RB Configuration)

FCC ID: BCG-A2984	PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 16 of 57



Plot 7-5. Occupied Bandwidth Plot (LTE Band 26 - 5MHz QPSK - Full RB Configuration)

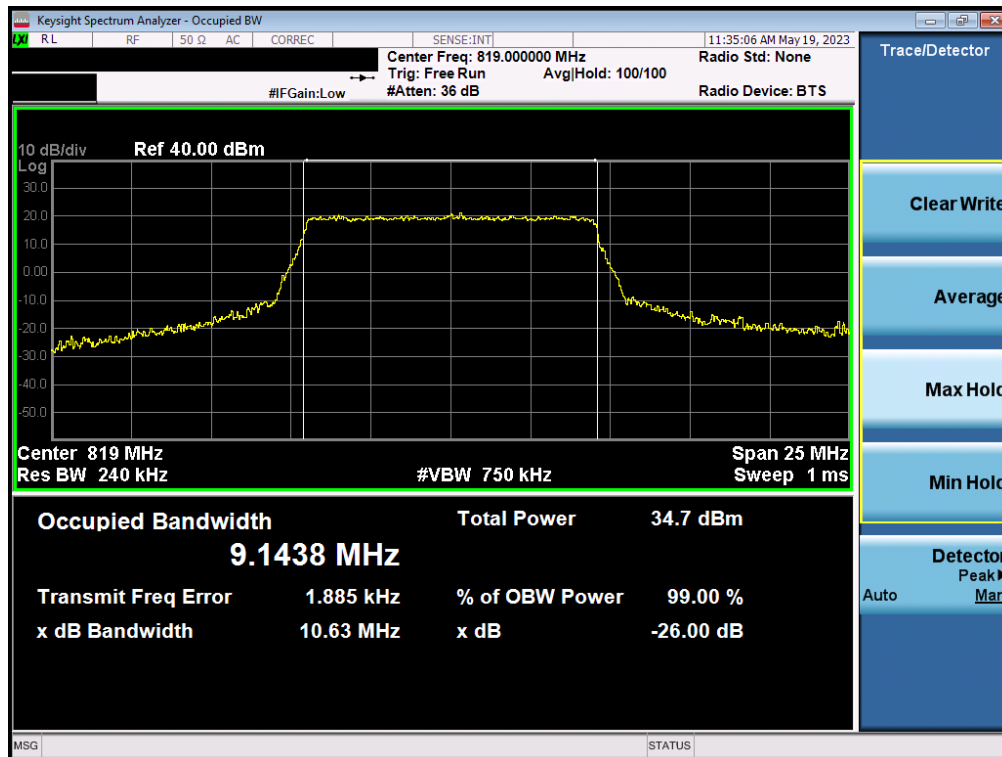


Plot 7-6. Occupied Bandwidth Plot (LTE Band 26 - 5MHz 16-QAM - Full RB Configuration)

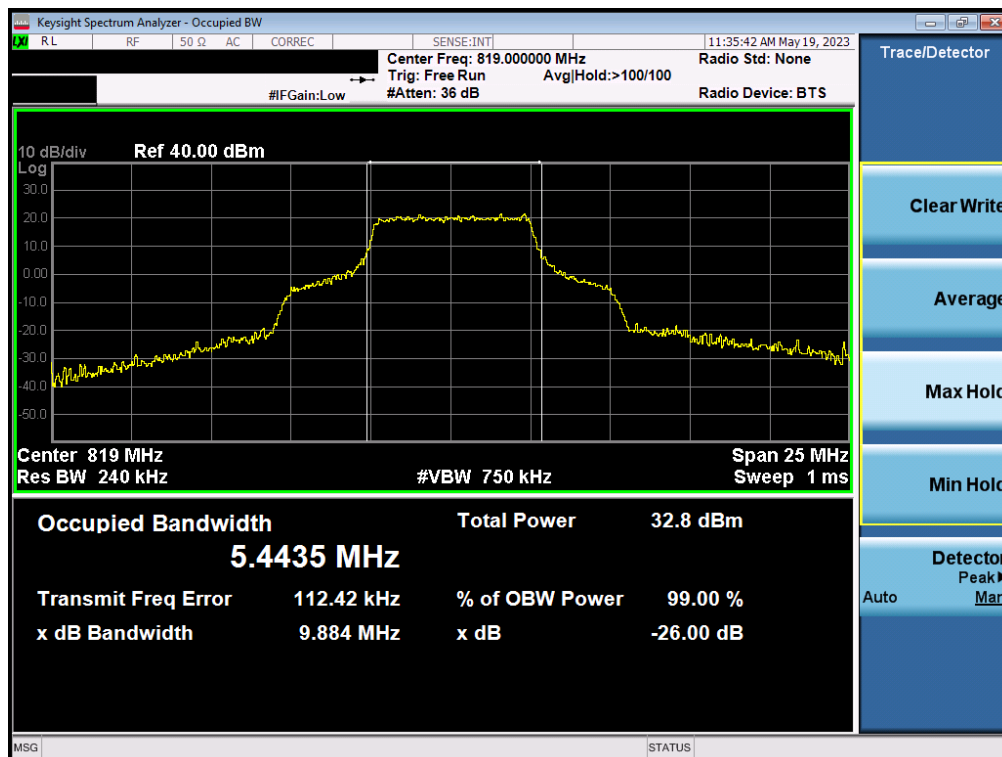
FCC ID: BCG-A2984	PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 17 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com



Plot 7-7. Occupied Bandwidth Plot (LTE Band 26 - 10MHz QPSK - Full RB Configuration)



Plot 7-8. Occupied Bandwidth Plot (LTE Band 26 - 10MHz 16-QAM - Full RB Configuration)

LTE Band 14

FCC ID: BCG-A2984	PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 18 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

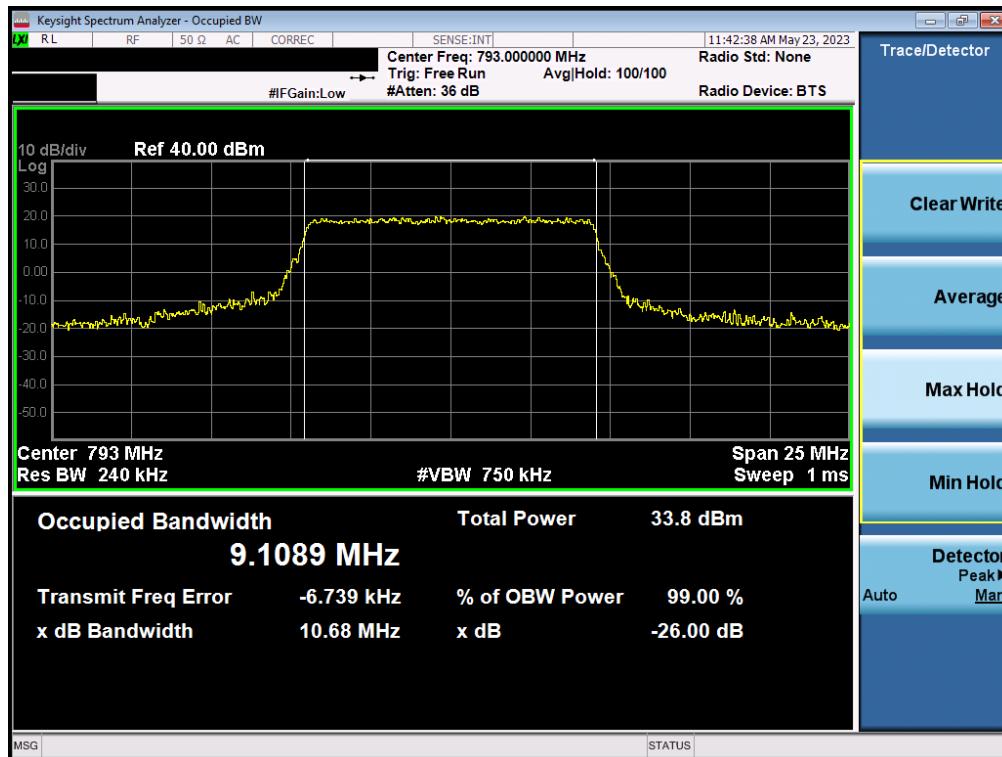


Plot 7-9. Occupied Bandwidth Plot (LTE Band 14 - 5MHz QPSK - Full RB Configuration)



Plot 7-10. Occupied Bandwidth Plot (LTE Band 14 - 5MHz 16-QAM - Full RB Configuration)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 19 of 57



Plot 7-11. Occupied Bandwidth Plot (LTE Band 14 - 10MHz QPSK - Full RB Configuration)



Plot 7-12. Occupied Bandwidth Plot (LTE Band 14 - 10MHz 16-QAM - Full RB Configuration)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 20 of 57

7.2 Spurious and Harmonic Emissions at Antenna Terminal

§2.1051 §90.691(a) §90.543(e)

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation and all ports were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is $43 + 10 \log_{10}(P_{\text{Watts}})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 6.0

Test Settings

1. Start frequency was set to 30MHz and stop frequency was set to 10GHz (separated into at least two plots per channel)
2. RBW $\geq$ 100kHz
3. VBW $\geq$ 3 x RBW
4. Detector = RMS
5. Trace mode = max hold
6. Sweep time = auto couple
7. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

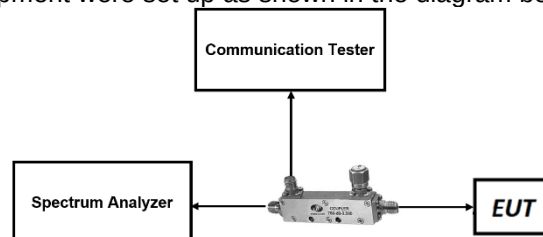


Figure 7-2. Test Instrument & Measurement Setup

Test Notes

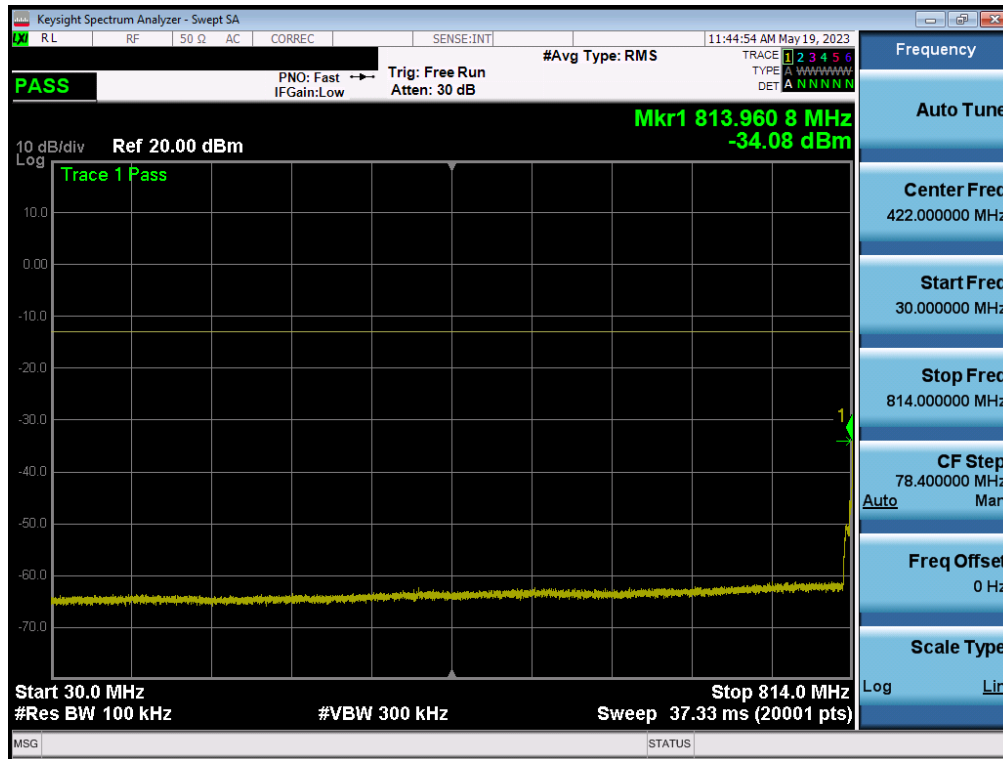
Compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kHz or greater for Part 90. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 21 of 57

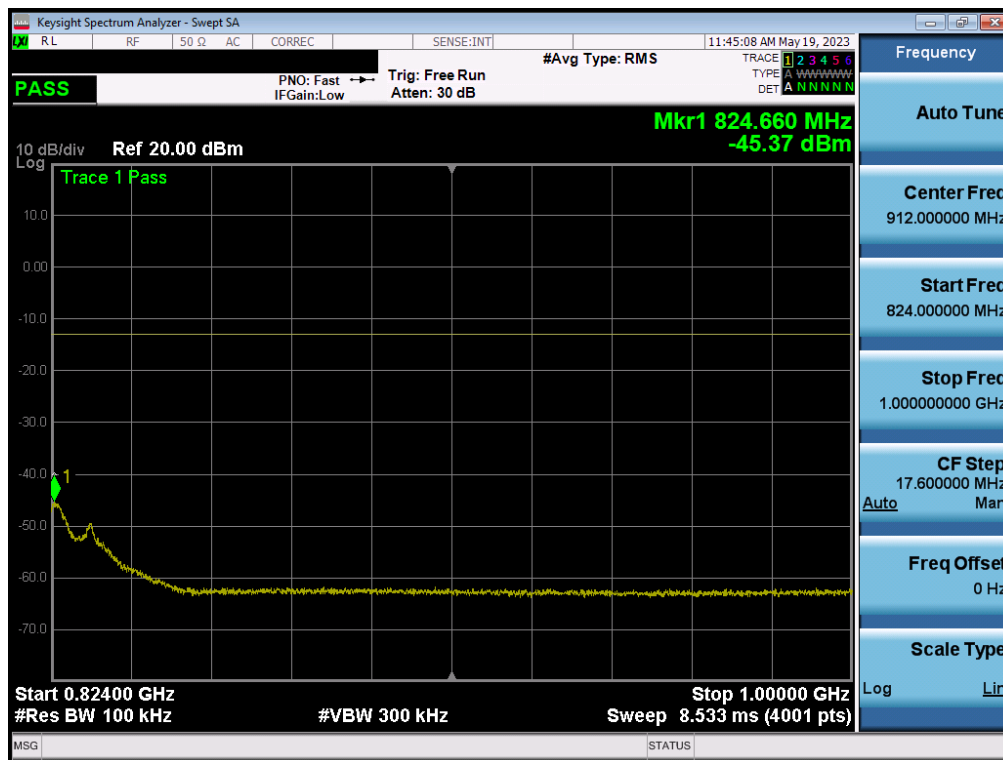
V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

LTE Band 26

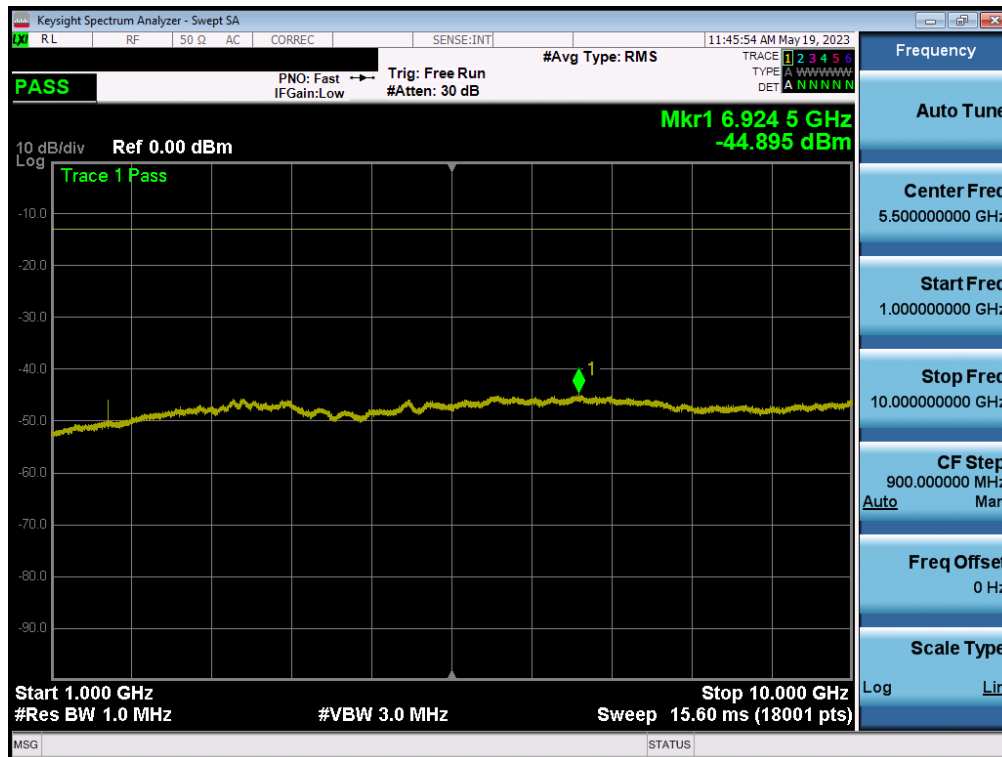


Plot 7-13. Conducted Spurious Plot (LTE Band 26 - 5MHz QPSK - RB Size 1, RB Offset 0 – Low Channel)

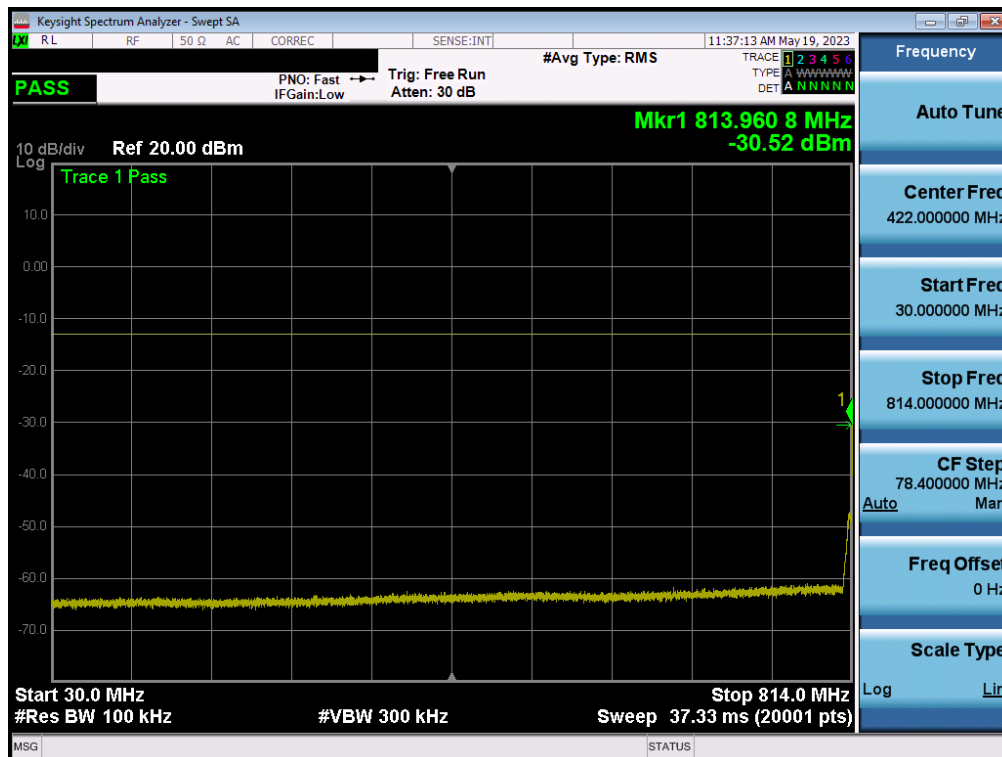


Plot 7-14. Conducted Spurious Plot (LTE Band 26 - 5MHz QPSK - RB Size 1, RB Offset 0 – Low Channel)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 22 of 57

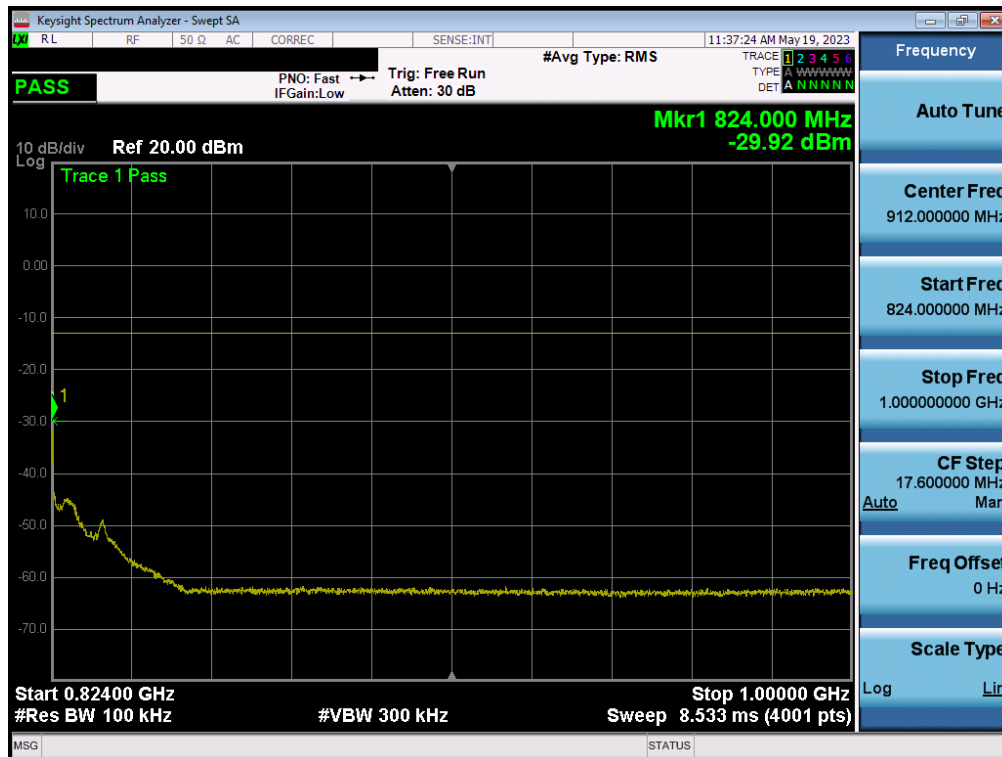


Plot 7-15. Conducted Spurious Plot (LTE Band 26 - 5MHz QPSK - RB Size 1, RB Offset 0 – Low Channel)

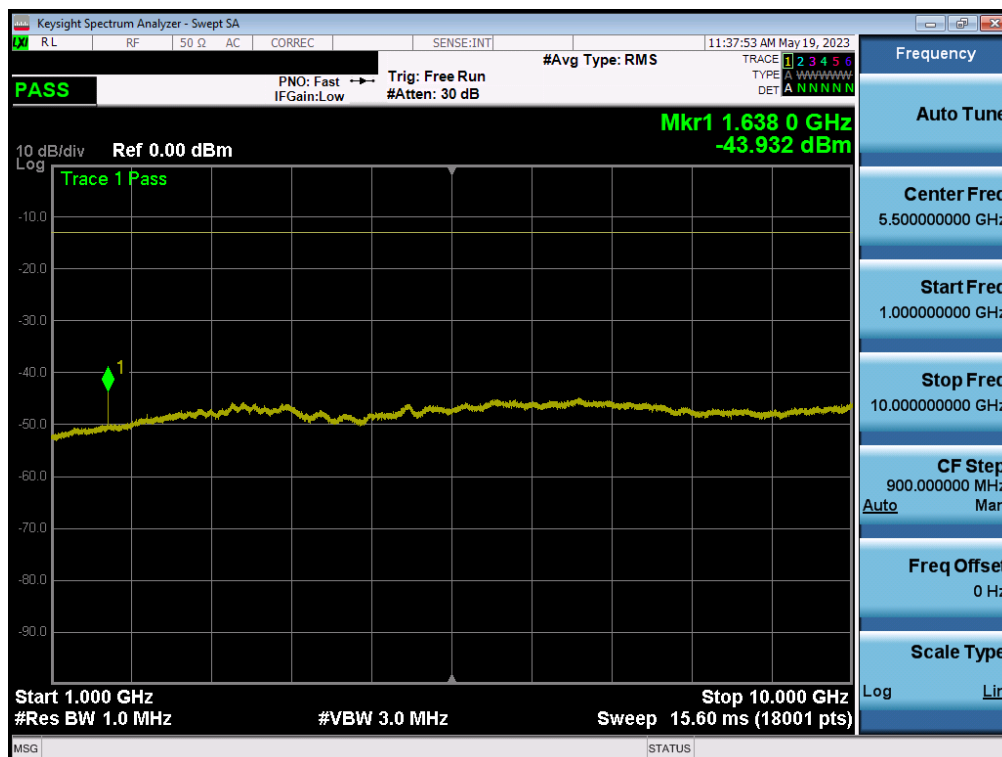


Plot 7-16. Conducted Spurious Plot (LTE Band 26 - 10MHz QPSK - RB Size 1, RB Offset 0)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 23 of 57



Plot 7-17. Conducted Spurious Plot (LTE Band 26 - 10MHz QPSK - RB Size 1, RB Offset 0)

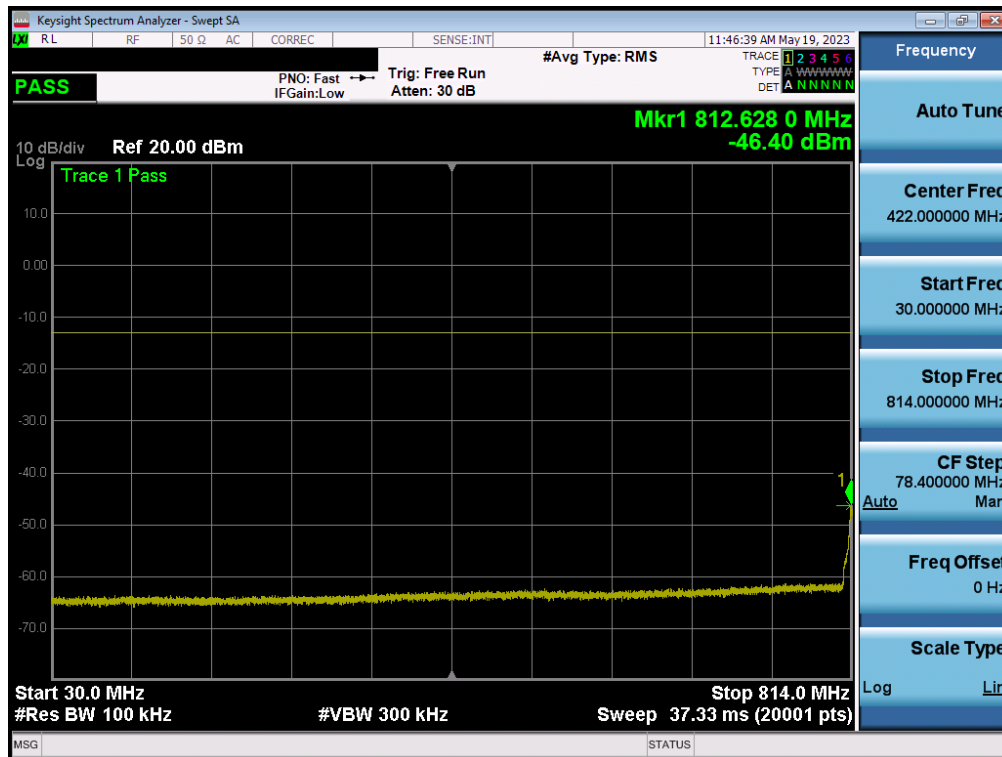


Plot 7-18. Conducted Spurious Plot (LTE Band 26 - 10MHz QPSK - RB Size 1, RB Offset 0)

FCC ID: BCG-A2984	PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 24 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

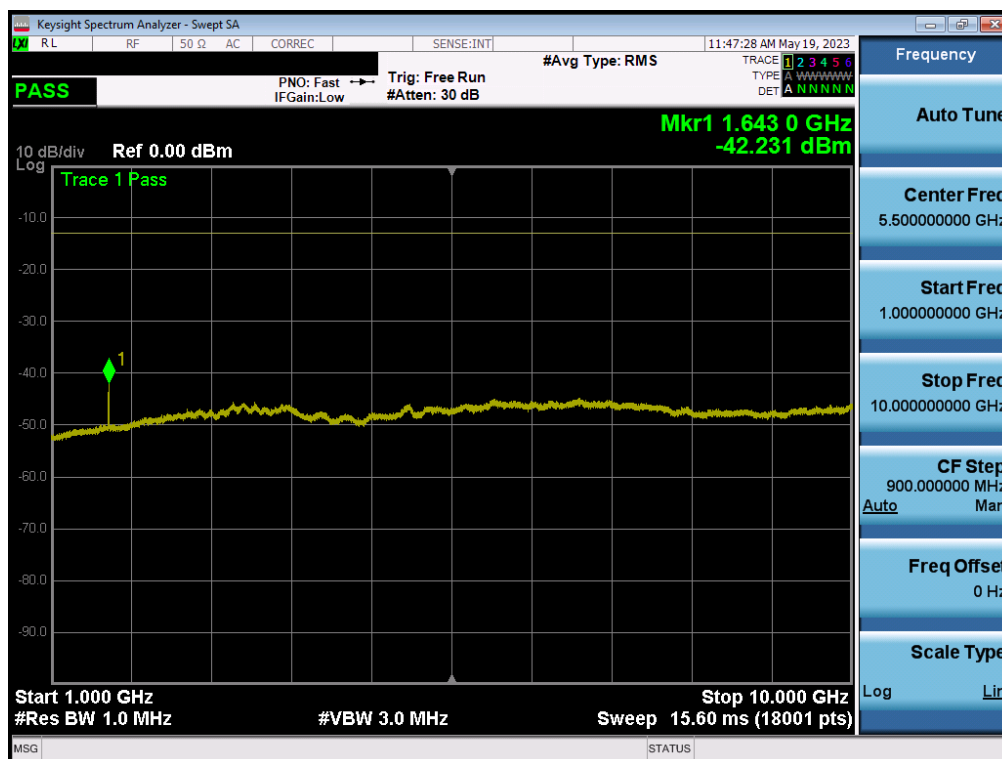


Plot 7-19. Conducted Spurious Plot (LTE Band 26 - 5MHz QPSK - RB Size 1, RB Offset 0 – High Channel)



Plot 7-20. Conducted Spurious Plot (LTE Band 26 - 5MHz QPSK - RB Size 1, RB Offset 0 – High Channel)

FCC ID: BCG-A2984	element PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 25 of 57

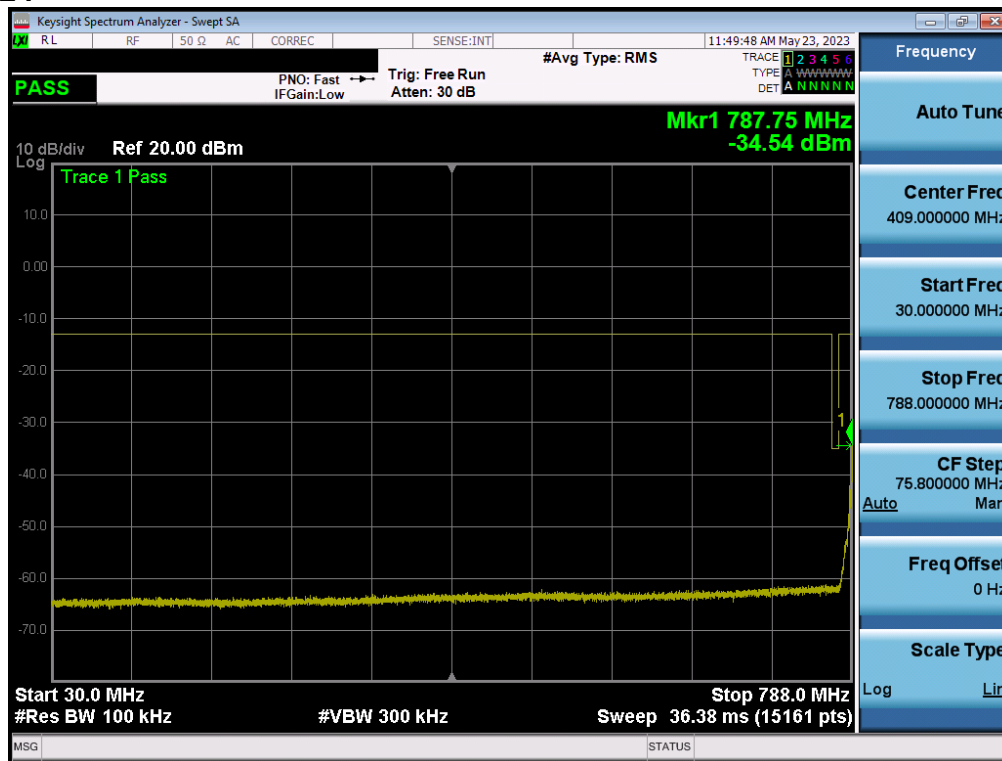


Plot 7-21. Conducted Spurious Plot (LTE Band 26 - 5MHz QPSK - RB Size 1, RB Offset 0 – High Channel)

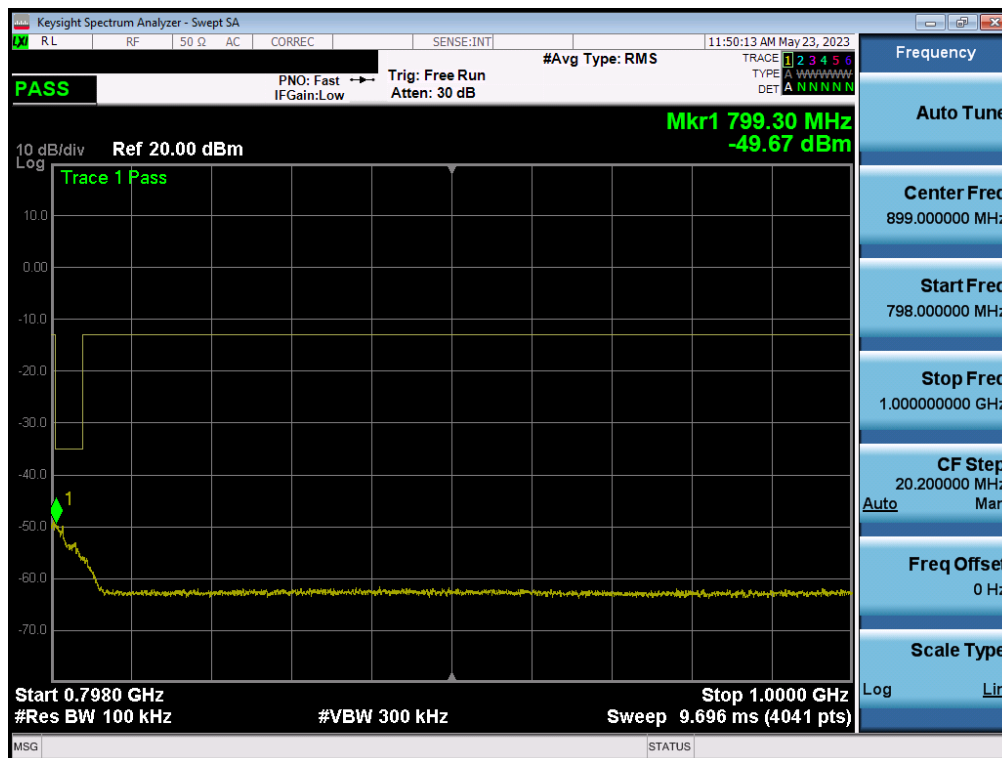
FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 26 of 57

V2.1 11/9/2021

LTE Band 14



Plot 7-22. Conducted Spurious Plot (LTE Band 14 - 5MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

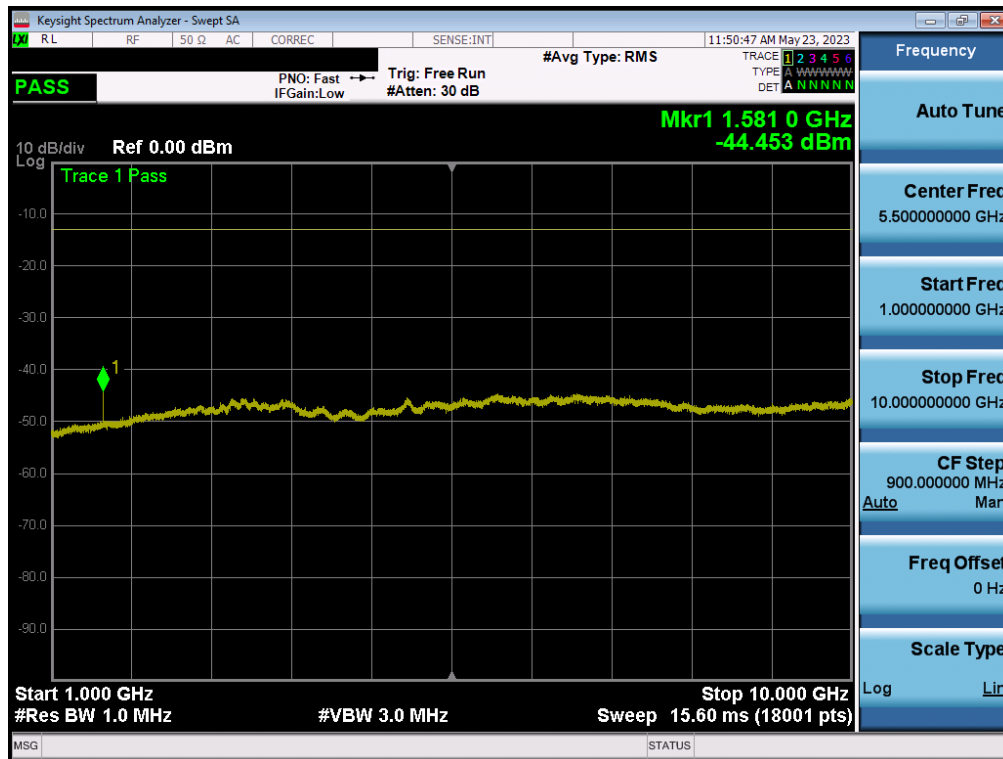


Plot 7-23. Conducted Spurious Plot (LTE Band 14 - 5MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

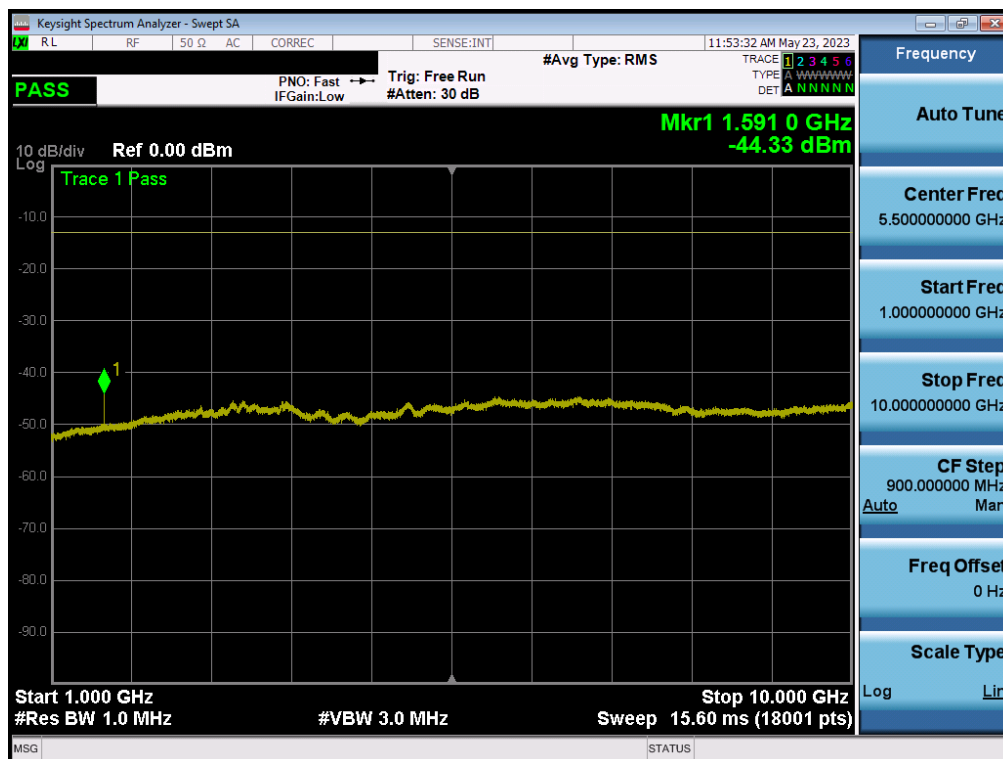
FCC ID: BCG-A2984	PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 27 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

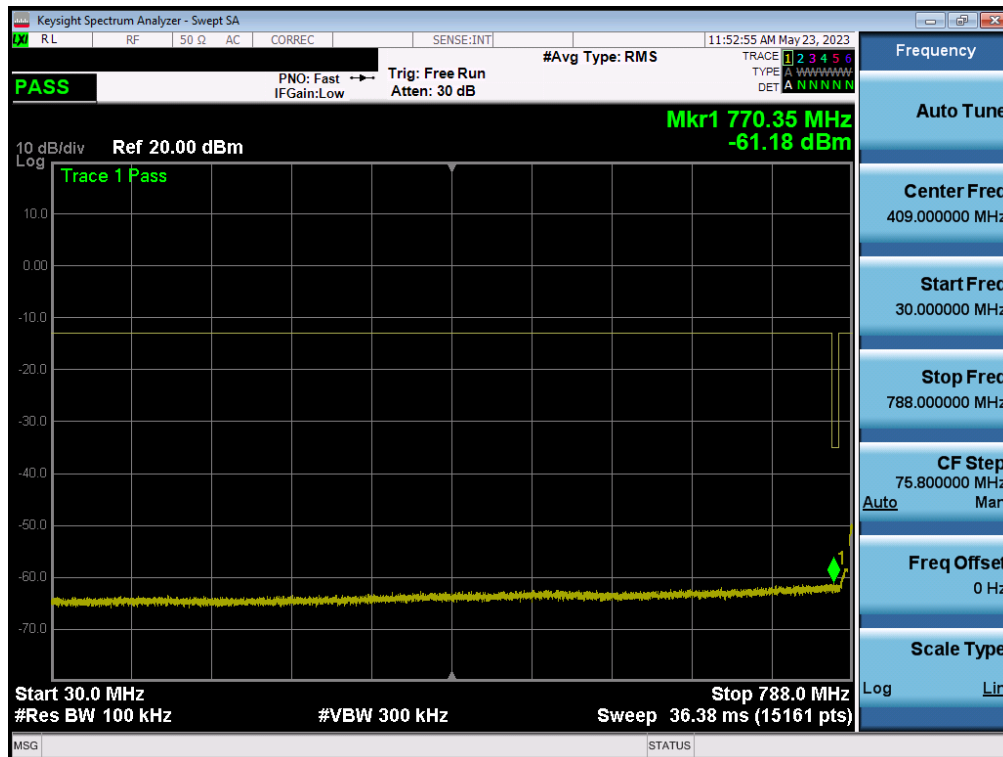


Plot 7-24. Conducted Spurious Plot (LTE Band 14 - 5MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

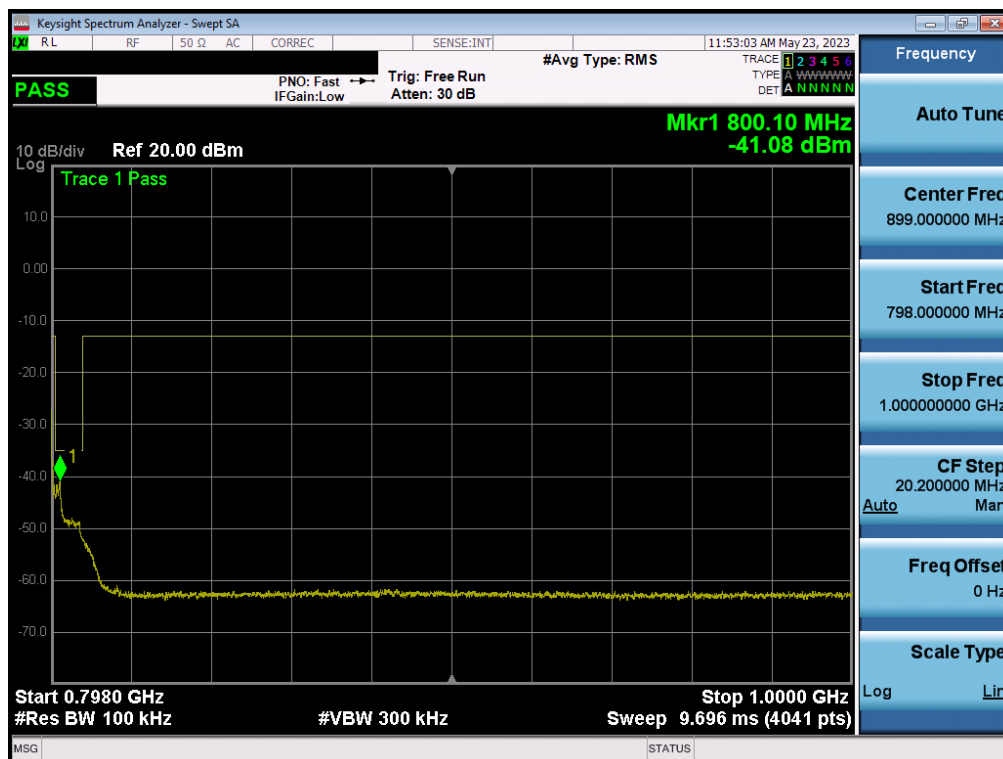


Plot 7-25. Conducted Spurious Plot (LTE Band 14 - 5MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 28 of 57

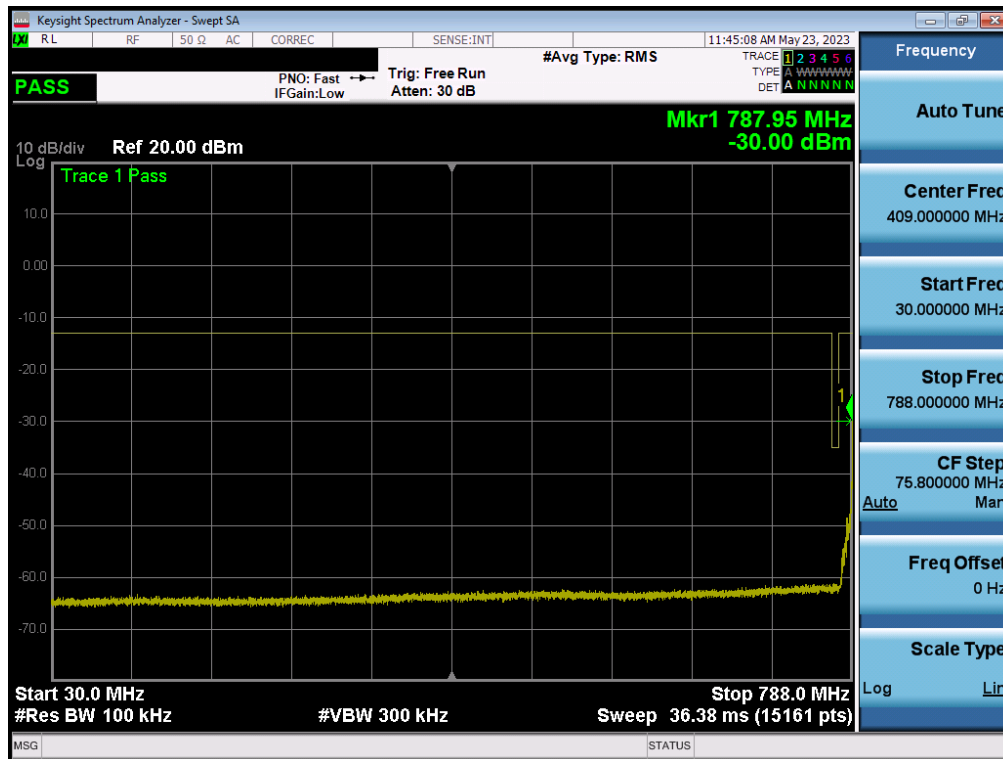


Plot 7-26. Conducted Spurious Plot (LTE Band 14 - 5MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

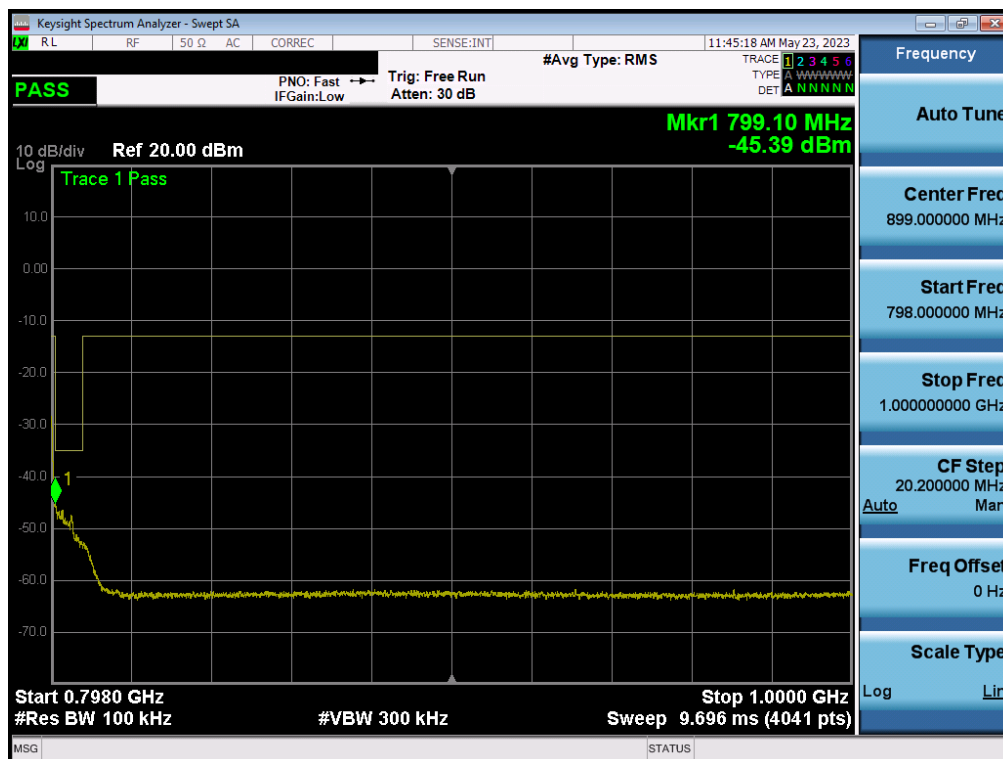


Plot 7-27. Conducted Spurious Plot (LTE Band 14 - 5MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 29 of 57

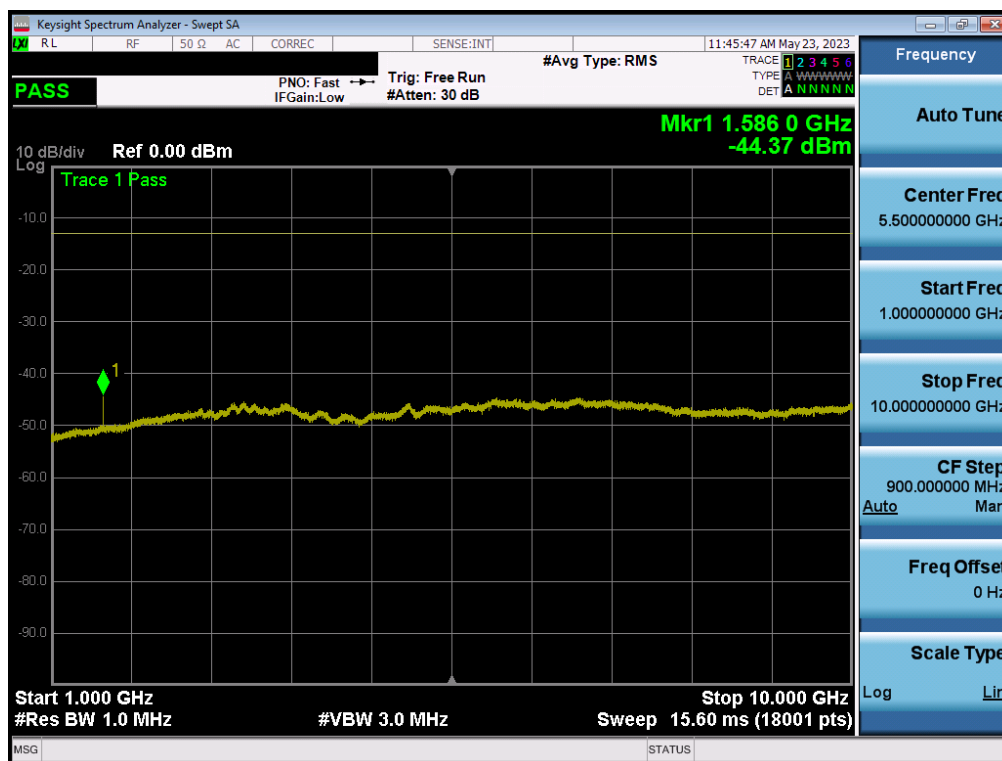


Plot 7-28. Conducted Spurious Plot (LTE Band 14 - 10MHz QPSK - RB Size 1, RB Offset 0)



Plot 7-29. Conducted Spurious Plot (LTE Band 14 - 10MHz QPSK - RB Size 1, RB Offset 0)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 30 of 57



Plot 7-30. Conducted Spurious Plot (LTE Band 14 - 10MHz QPSK - RB Size 1, RB Offset 0)

FCC ID: BCG-A2984	PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 31 of 57

V2.1 11/9/2021

7.3 Band Edge Emissions at Antenna Terminal

§2.1051 §90.691(a) §90.543(e)

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section. All ports were tested and only the worst case data were reported.

For LTE B26 operation under Part 90.691, the minimum permissible attenuation level of any spurious emission removed from the EA licensee's frequency block by greater than 37.5 kHz is $43 + 10\log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts. The minimum permissible attenuation level of any spurious emission removed from the EA licensee's frequency block by up to and including 37.5 kHz is $50 + 10\log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 6.0

Test Settings

1. Span was set large enough so as to capture all out of band emissions near the band edge
2. RBW = 100 kHz
3. VBW = 300 kHz
4. Detector = RMS
5. Trace mode = trace average
6. Sweep time = auto couple
7. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

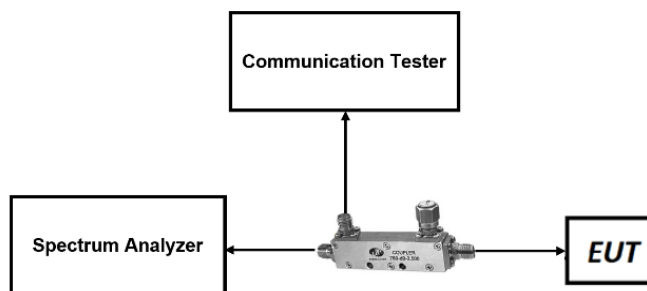


Figure 7-3. Test Instrument & Measurement Setup

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch
		Page 32 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

Test Notes

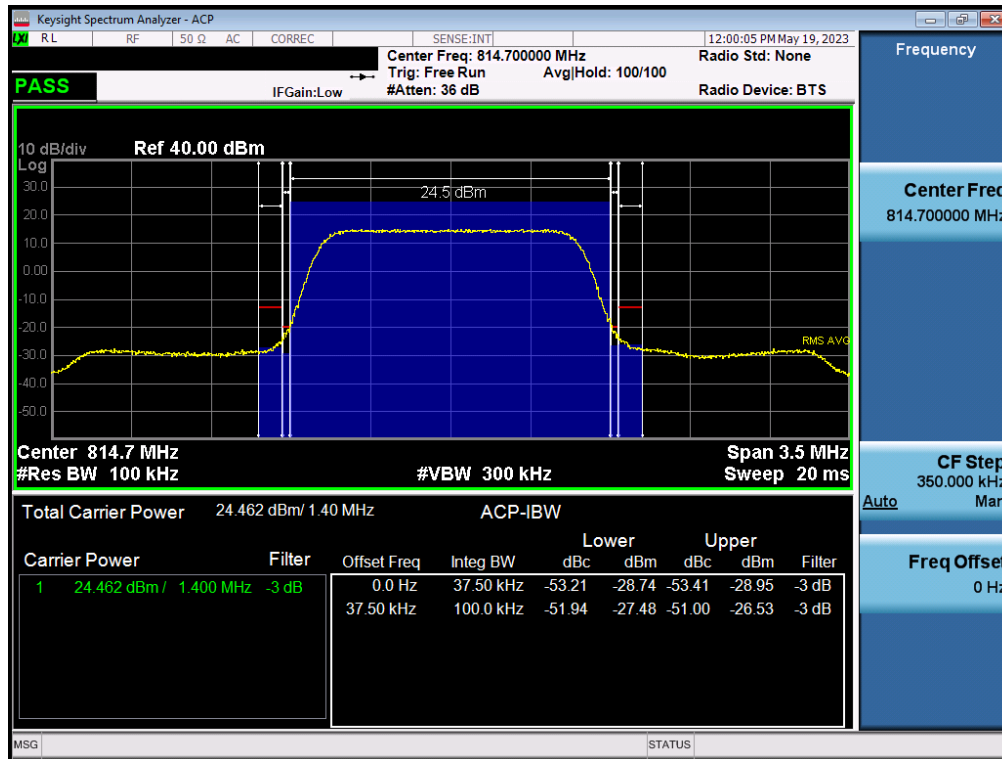
1. For channel edge emission, the signal analyzer's "ACP" measurement capability is used.
2. Per Part 90, in the 100 kHz bands immediately outside and adjacent to the frequency block, a resolution bandwidth of 30 kHz may be employed to demonstrate compliance with the out-of-band emissions limit. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center.
3. For LTE Band 14 operation under Part 90.543, the power of any emission must be reduced below the mean output power (P) by at least $43 + 10\log(P)$ dB measured in a 100 kHz bandwidth for frequencies less than 1 GHz, and in a 1 MHz bandwidth for frequencies greater than 1 GHz.
4. Additionally, for LTE Band 14 operation, on all frequencies between 769-775 MHz and 799-805 MHz, the power of any emission shall be attenuated by a factor not less than $65 + 10\log(P)$ dB in a 6.25 kHz band segment, for mobile and portable stations.

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch
		Page 33 of 57

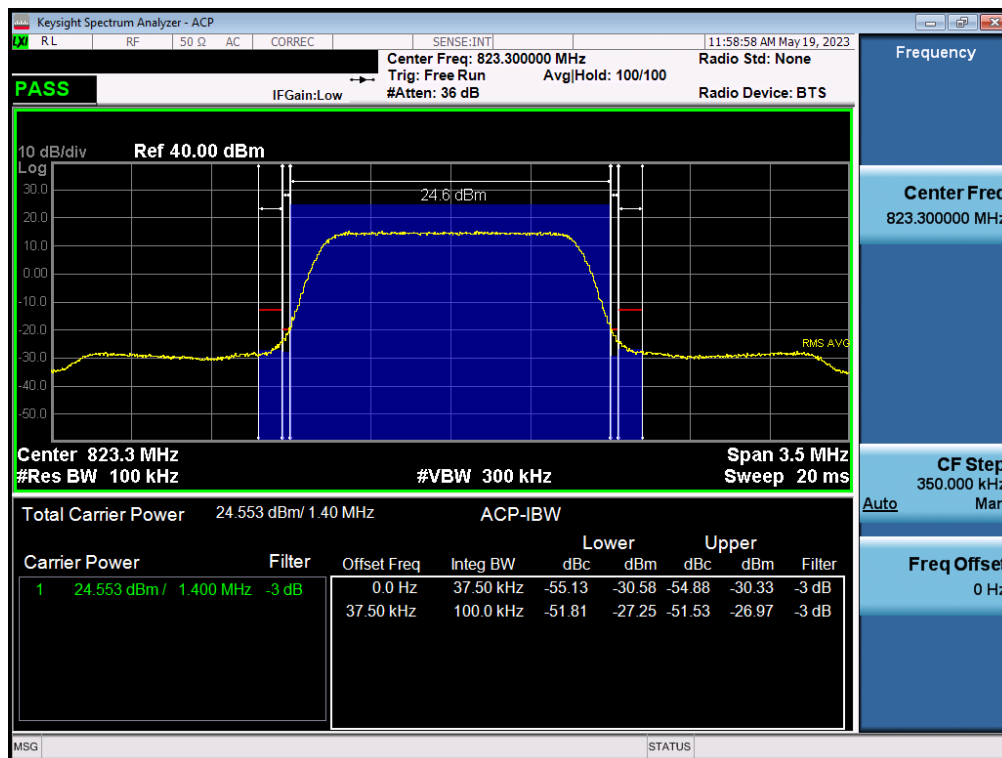
V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

LTE Band 26



Plot 7-31. Channel Edge Plot (LTE Band 26 - 1.4MHz QPSK - Low Channel)

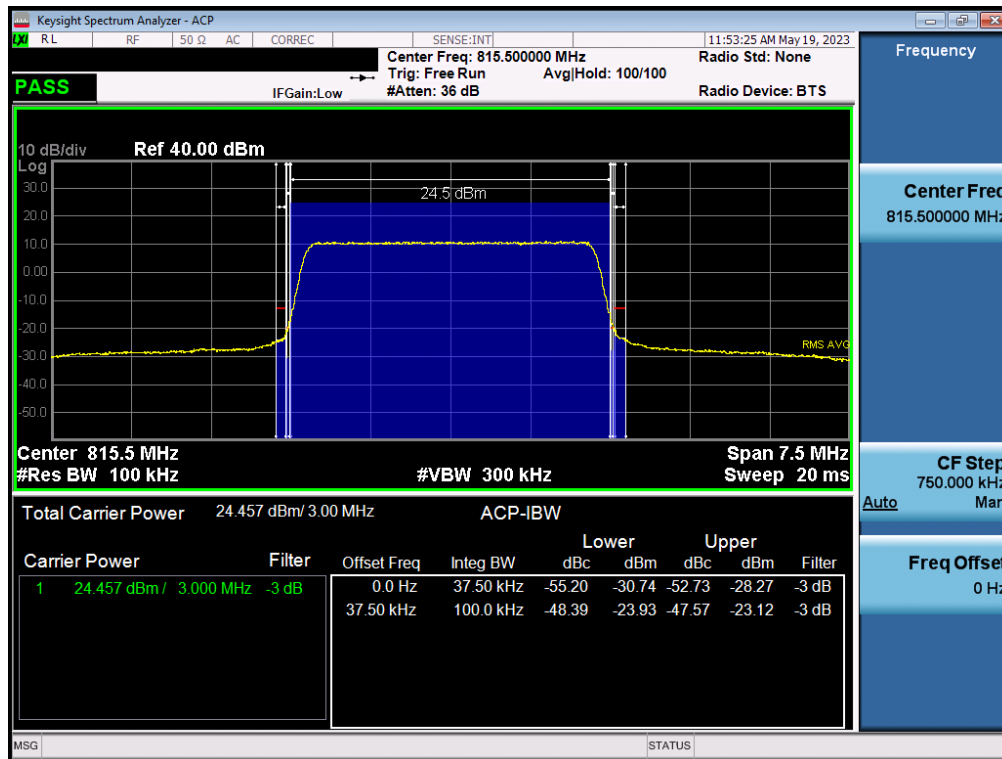


Plot 7-32. Channel Edge Plot (LTE Band 26 - 1.4MHz QPSK - High Channel)

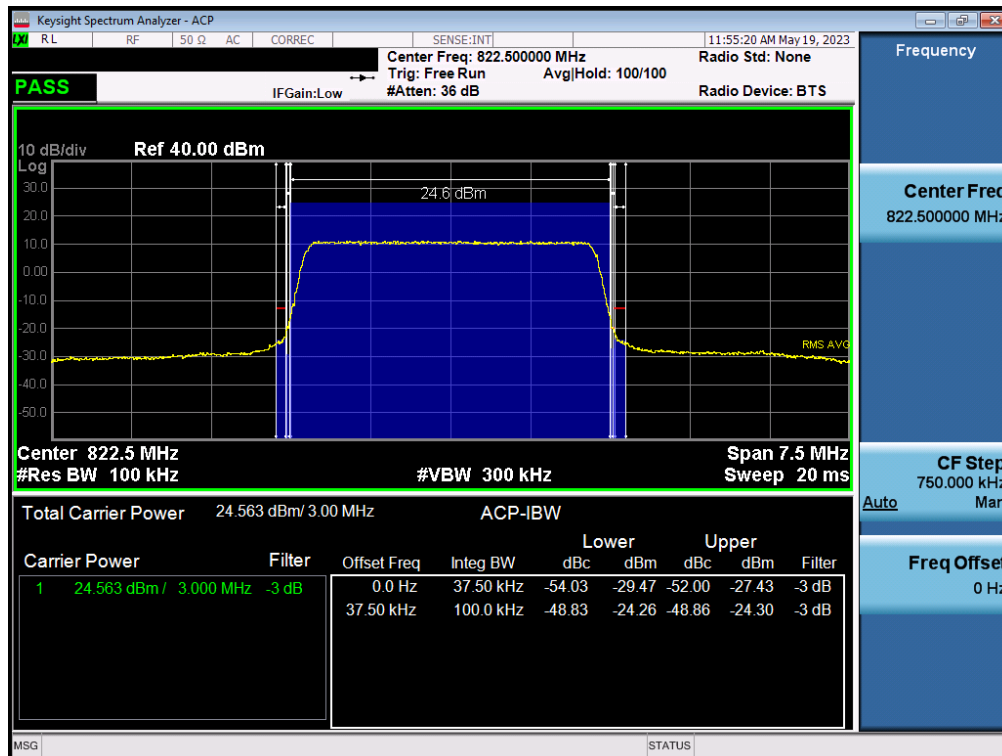
FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 34 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

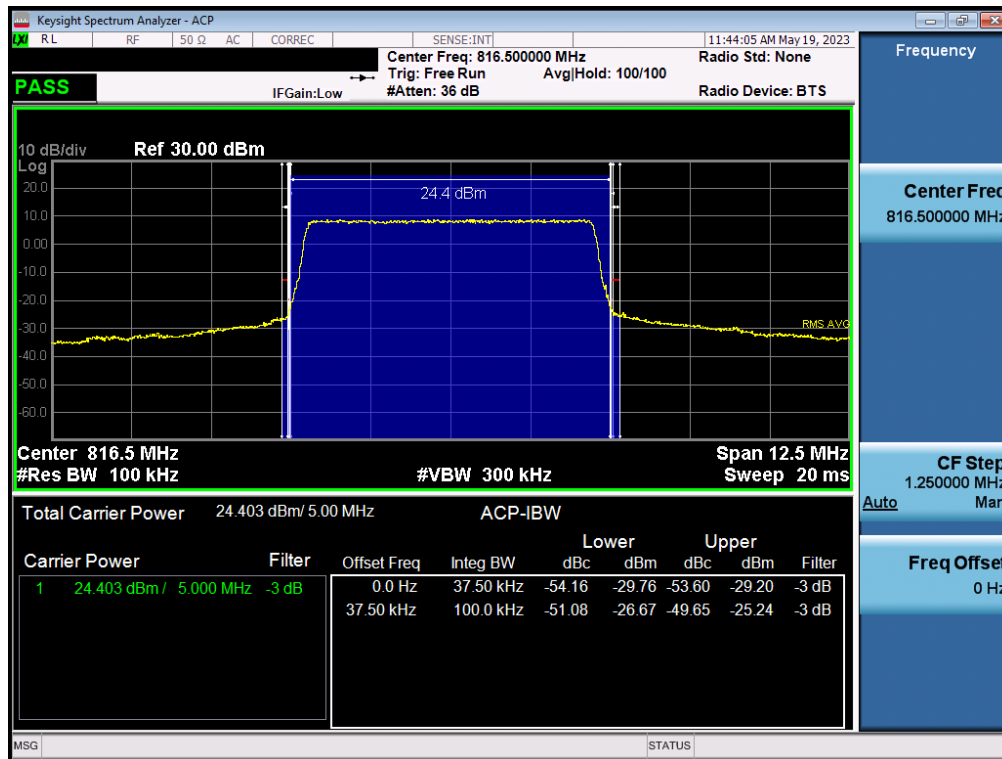


Plot 7-33. Channel Edge Plot (LTE Band 26 - 3MHz QPSK - Low Channel)

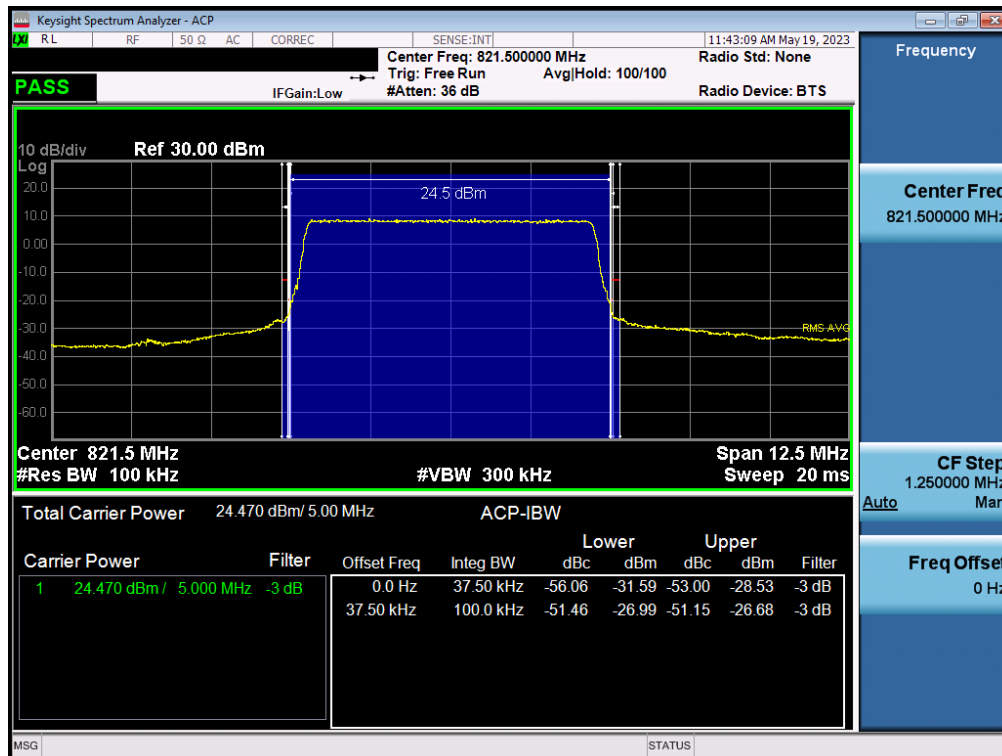


Plot 7-34. Channel Edge Plot (LTE Band 26 - 3MHz QPSK - High Channel)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 35 of 57

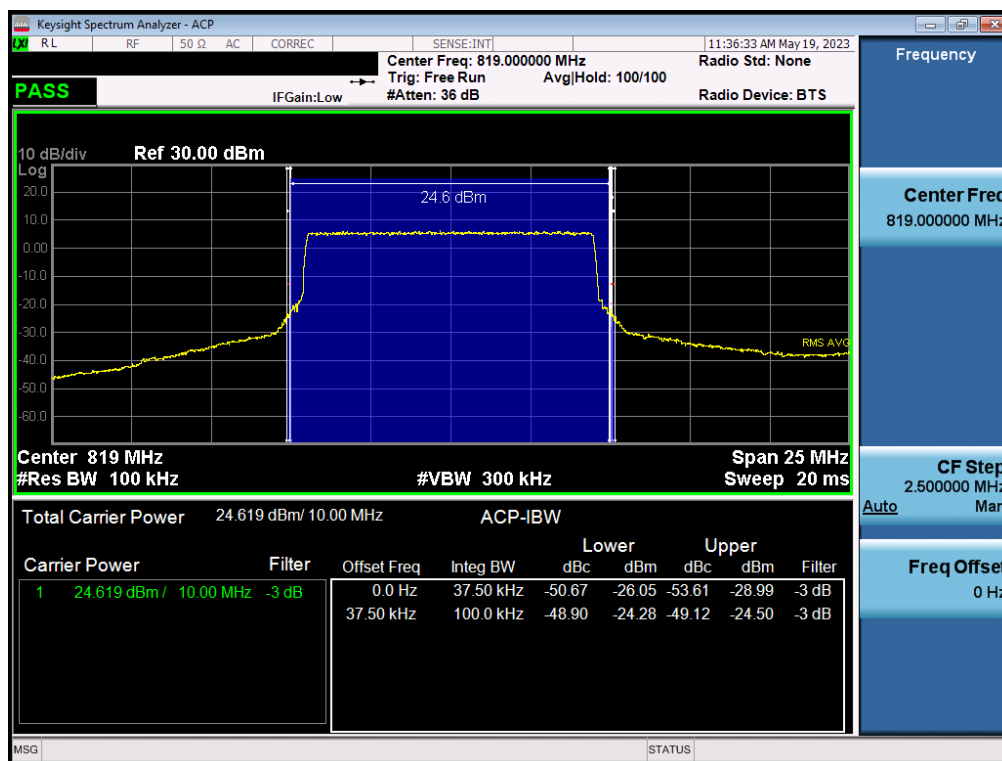


Plot 7-35. Channel Edge Plot (LTE Band 26 - 5MHz QPSK - Low Channel)



Plot 7-36. Channel Edge Plot (LTE Band 26 - 5MHz QPSK - High Channel)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 36 of 57

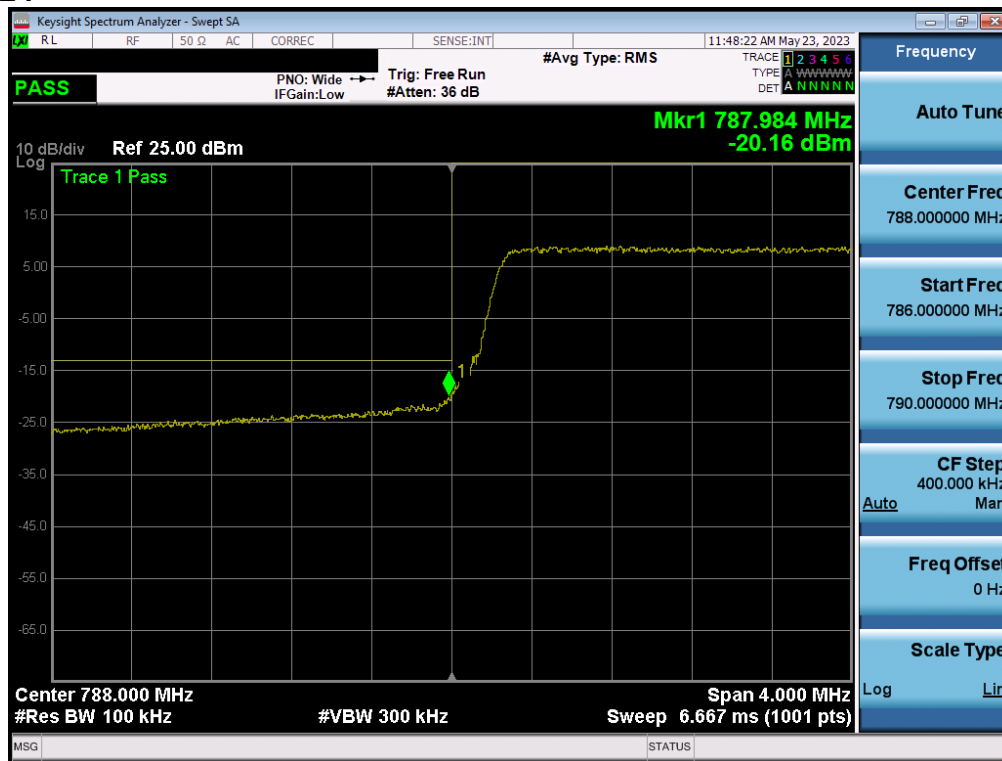


Plot 7-37. Channel Edge Plot (LTE Band 26 - 10MHz QPSK - Mid Channel)

FCC ID: BCG-A2984	PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 37 of 57

V2.1 11/9/2021

LTE Band 14



Plot 7-38. Lower Band Edge Plot (LTE Band 14, 5MHz QPSK - RB Size 25)



Plot 7-39. Lower Emission Mask Plot (LTE Band 14, 5MHz QPSK - RB Size 25)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 38 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

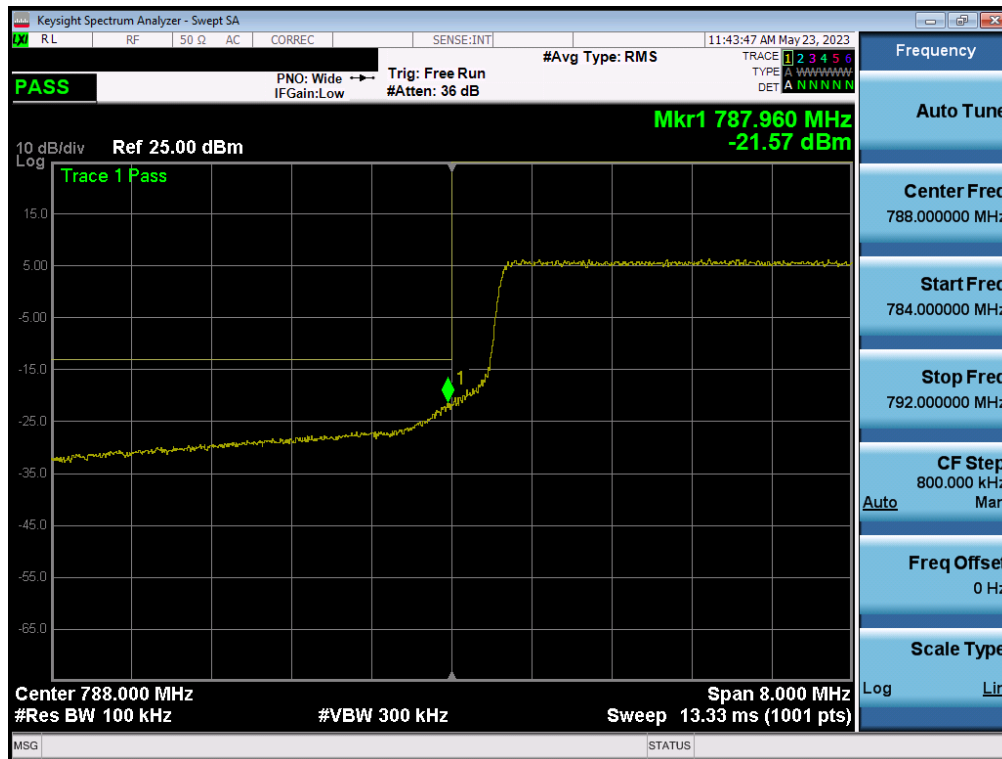


Plot 7-40. Upper Band Edge Plot (LTE Band 14, 5MHz QPSK - RB Size 25)



Plot 7-41. Upper Emission Mask Plot (LTE Band 14, 5MHz QPSK - RB Size 25)

FCC ID: BCG-A2984	PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 39 of 57



Plot 7-42. Lower Band Edge Plot (LTE Band 14, 10MHz QPSK - RB Size 50)



Plot 7-43. Lower Emission Mask Plot (LTE Band 14, 10MHz QPSK - RB Size 50)

FCC ID: BCG-A2984	PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 40 of 57



Plot 7-44. Upper Band Edge Plot (LTE Band 14, 10MHz QPSK - RB Size 50)



Plot 7-45. Upper Emission Mask Plot (LTE Band 14, 10MHz QPSK - RB Size 50)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 41 of 57

7.4 Conducted Power Output Data

\$2.1046 \$90.635

Test Overview

Conducted power measurements are performed to measure the average output power of the EUT. The averaging is to be performed only over duration of active transmissions at maximum output power level. The average measurements do not include averaging over periods when the transmitter is quiescent or when operating at reduced power level.

Test Procedures Used

KDB 971168 D01 v03r01

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

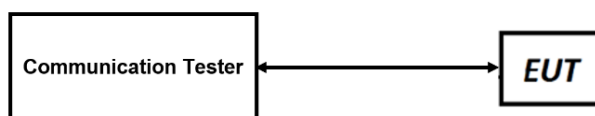


Figure 7-4. Conducted Power Measurement Setup

Test Notes

1. The EUT was tested in all possible test configurations. The worst case emissions are reported with the EUT modulations and channel bandwidth configurations shown in the tables below.

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 42 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

Antenna BCM

Bandwidth	Modulation	Channel	Frequency [MHz]	RB Size/Offset	Conducted Power [dBm]	Conducted Power [mW]	Conducted Power Limit [dBm]	Margin [dB]
1.4 MHz	QPSK	26697	814.7	1 / 0	25.50	354.813	50.00	-24.50
		26783	823.3	1 / 5	25.39	345.939	50.00	-24.61
	16-QAM	26697	814.7	1 / 3	24.88	307.610	50.00	-25.12
3 MHz	QPSK	26705	815.5	1 / 0	25.50	354.813	50.00	-24.50
		26775	822.5	1 / 14	25.48	353.183	50.00	-24.52
	16-QAM	26775	822.5	1 / 14	24.90	309.030	50.00	-25.10
5 MHz	QPSK	26715	816.5	1 / 0	25.50	354.813	50.00	-24.50
		26765	821.5	1 / 12	25.47	352.371	50.00	-24.53
	16-QAM	26715	816.5	1 / 24	24.68	293.765	50.00	-25.32
10 MHz	QPSK	26740	819.0	1 / 0	25.50	354.813	50.00	-24.50
	16-QAM	26740	819.0	1 / 0	24.91	309.742	50.00	-25.09

Table 7-2. Conducted Power Output Data (LTE Band 26)

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 43 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

7.5 Radiated Power (ERP)

§90.542(a)(7)

Test Overview

Effective Radiated Power (ERP) measurements are calculated by adding highest antenna gain to maximum measured conducted output power. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

Test Procedures Used

KDB 971168 D01 v03r01 – Section 5.2.1

ANSI C63.26-2015

TIA-603-E-2016 – Section 2.2.17

Test Settings

The relevant equation for determining the ERP from the conducted RF output power measured is:

$$\text{ERP} = \text{PMeas} - \text{LC} + \text{GT}$$

Where:

ERP = Effective Radiated Power (expressed in the same units as PMeas, typically dBW or dBm)

PMeas = measured transmitter output power or PSD, in dBW or dBm

LC = signal attenuation in the connecting cable between the transmitter and antenna in dB

GT = gain of the transmitting antenna, in dBd (ERP)

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

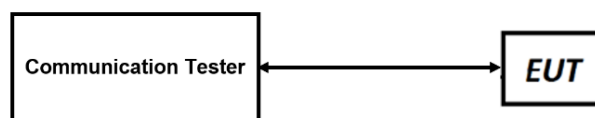


Figure 7-5. ERP Measurement Setup

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 44 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

Test Notes

- 1) The worst case emissions are reported with the modulations, RB sizes and offsets, and channel bandwidth configurations shown in the tables below.
- 2) This unit was tested with its standard battery.
- 3) The Level (dBm) readings in the table were taken with a correction table loaded into the base station simulator. The correction table was used to account for the signal attenuation in the connecting cable between the transmitter and antenna.
- 4) The Ant. Gains (GT) are listed in dBi.

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 45 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

7.5.1 Antenna BCM - ERP

Bandwidth	Mod.	Frequency [MHz]	Ant. Gain [dBi]	RB Size/Offset	Conducted Power [dBm]	ERP [dBm]	ERP [mW]	ERP Limit [dBm]	Margin [dB]
5 MHz	QPSK	790.5	-28.50	1 / 24	25.50	-5.15	0.305	34.77	-39.92
		793.0	-28.50	1 / 0	25.50	-5.15	0.305	34.77	-39.92
		795.5	-28.50	1 / 12	25.37	-5.28	0.296	34.77	-40.05
10 MHz	16-QAM	793.0	-28.50	1 / 12	25.01	-5.64	0.273	34.77	-40.41
	QPSK	793.0	-28.50	1 / 25	25.34	-5.31	0.294	34.77	-40.08
	16-QAM	793.0	-28.50	1 / 0	24.91	-5.74	0.267	34.77	-40.51

Table 7-3. ERP Data (LTE Band 14)

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 46 of 57

V2.1 11/9/2021

7.6 Radiated Spurious Emissions

§2.1051 §90.691(a) §90.543(e)

Test Overview

Radiated spurious emissions measurements are performed using the field strength conversion method described in KDB 971168 with the EUT transmitting into an integral antenna. Measurements on signals operating below 1GHz are performed using horizontally and vertically polarized broadband hybrid antennas. Measurements on signals operating above 1GHz are performed using vertically and horizontally polarized broadband horn antennas. All measurements are performed while the EUT is operating at maximum power and at the appropriate frequencies.

Test Procedures Used

KDB 971168 D01 v03r01 – Section 5.8

ANSI C63.26-2015

TIA-603-E-2016 – Section 2.2.12

Test Settings

1. RBW = 100kHz for emissions below 1GHz and 1MHz for emissions above 1GHz
2. VBW $\geq 3 \times$ RBW
3. Span = 1.5 times the OBW
4. No. of sweep points $\geq 2 \times$ span / RBW
5. Detector = RMS
6. Trace mode = Average (Max Hold for pulsed emissions)
7. The trace was allowed to stabilize

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 47 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

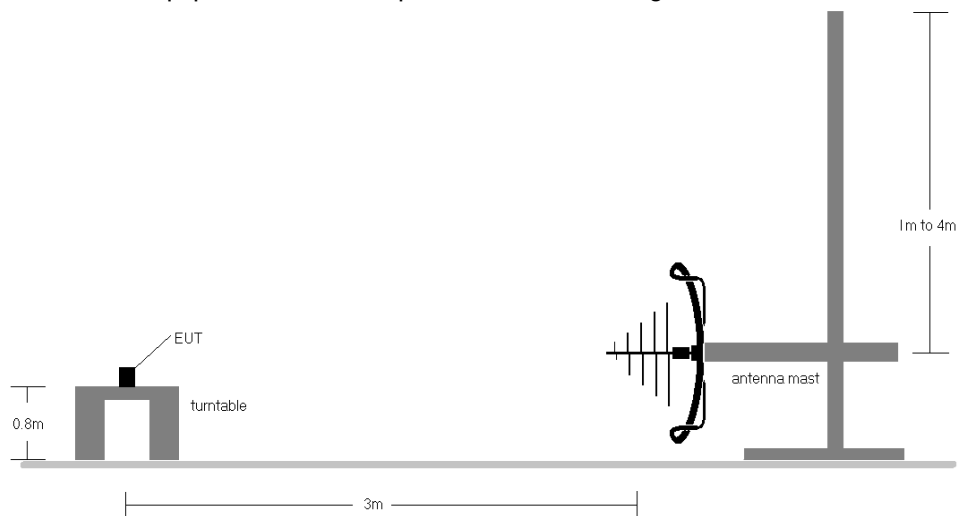


Figure 7-6. Test Instrument & Measurement Setup < 1GHz

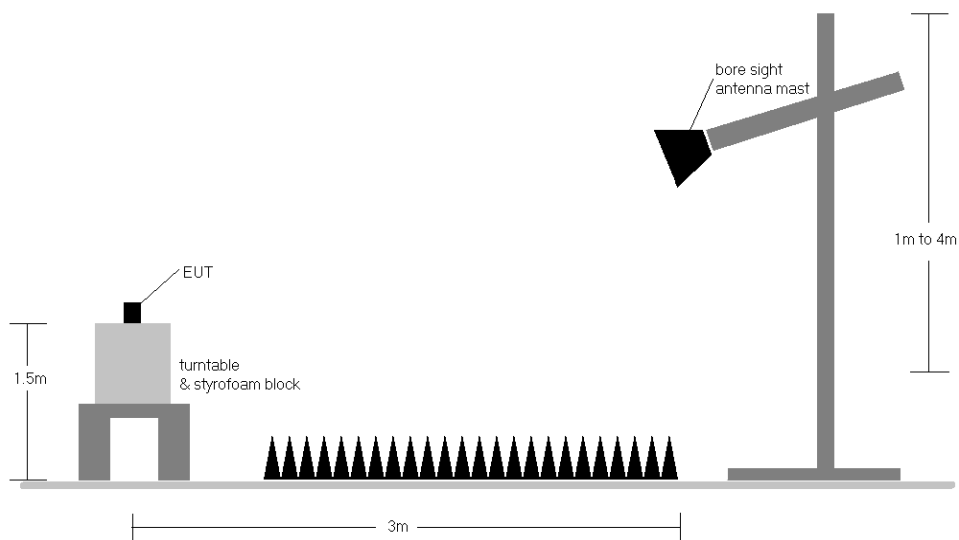


Figure 7-7. Test Instrument & Measurement Setup >1 GHz

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch
		Page 48 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

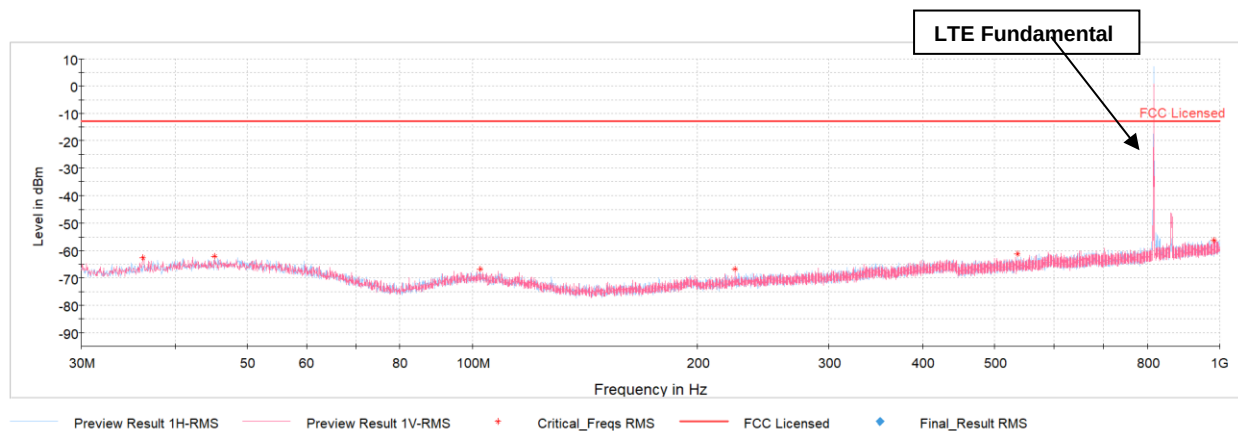
Test Notes

1. Field strengths are calculated using the Measurement quantity conversions in KDB 971168 Section 5.8.4.
 - a. $E(\text{dB}\mu\text{V}/\text{m}) = \text{Measured amplitude level (dBm)} + 107 + \text{Cable Loss (dB)} + \text{Antenna Factor (dB/m)}$
 - b. $\text{EIRP (dBm)} = E(\text{dB}\mu\text{V}/\text{m}) + 20\log D - 104.8$; where D is the measurement distance in meters.
2. For LTE mode, the device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported with 1 RB.
3. This unit was tested with its standard battery.
4. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case setup is reported in the tables below.
5. The "-" shown in the following RSE tables are used to denote a noise floor measurement.

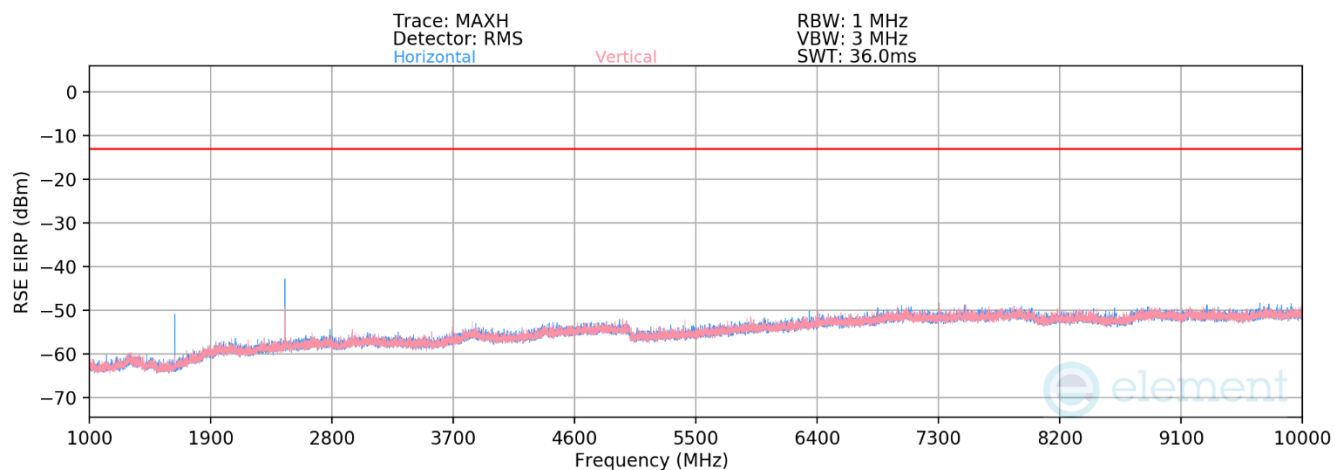
FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 49 of 57

V2.1 11/9/2021

7.6.1 Antenna BCM – Radiated Spurious Emission Measurements



Plot 7-46. Antenna BCM Radiated Spurious Plot below 1GHz (LTE Band 26)



Plot 7-47. Antenna BCM Radiated Spurious Plot above 1GHz (LTE Band 26)

FCC ID: BCG-A2984	element	PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 50 of 57

V2.1 11/9/2021

Bandwidth (MHz):	5
Frequency (MHz):	816.5
Modulation Signal:	QPSK
RB Config (Size / Offset):	1 / 12

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1633.0	H	291	5	-71.00	-4.82	31.18	-64.08	-13.00	-51.08
2449.5	H	102	2	-64.18	-0.09	42.73	-52.52	-13.00	-39.52
3266.0	H	-	-	-78.03	1.34	30.31	-64.94	-13.00	-51.94
4082.5	H	-	-	-78.77	3.11	31.34	-63.91	-13.00	-50.91

Table 7-4. Antenna BCM Radiated Spurious Data (LTE Band 26 - Low Channel)

Bandwidth (MHz):	10
Frequency (MHz):	819.0
Modulation Signal:	QPSK
RB Config (Size / Offset):	1 / 25

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1638.0	H	153	313	-69.47	-4.77	32.76	-62.50	-13.00	-49.50
2457.0	H	124	11	-65.27	-0.11	41.62	-53.64	-13.00	-40.64
3276.0	H	-	-	-78.05	1.38	30.33	-64.92	-13.00	-51.92
4095.0	H	-	-	-79.04	2.96	30.92	-64.34	-13.00	-51.34

Table 7-5. Antenna BCM Radiated Spurious Data (LTE Band 26 - Mid Channel)

Bandwidth (MHz):	5
Frequency (MHz):	821.5
Modulation Signal:	QPSK
RB Config (Size / Offset):	1 / 12

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1643.0	H	195	300	-68.77	-4.72	33.51	-61.75	-13.00	-48.75
2464.5	H	111	14	-68.47	-0.16	38.37	-56.88	-13.00	-43.88
3286.0	H	-	-	-77.98	1.45	30.47	-64.78	-13.00	-51.78
4107.5	H	-	-	-79.07	2.94	30.87	-64.39	-13.00	-51.39

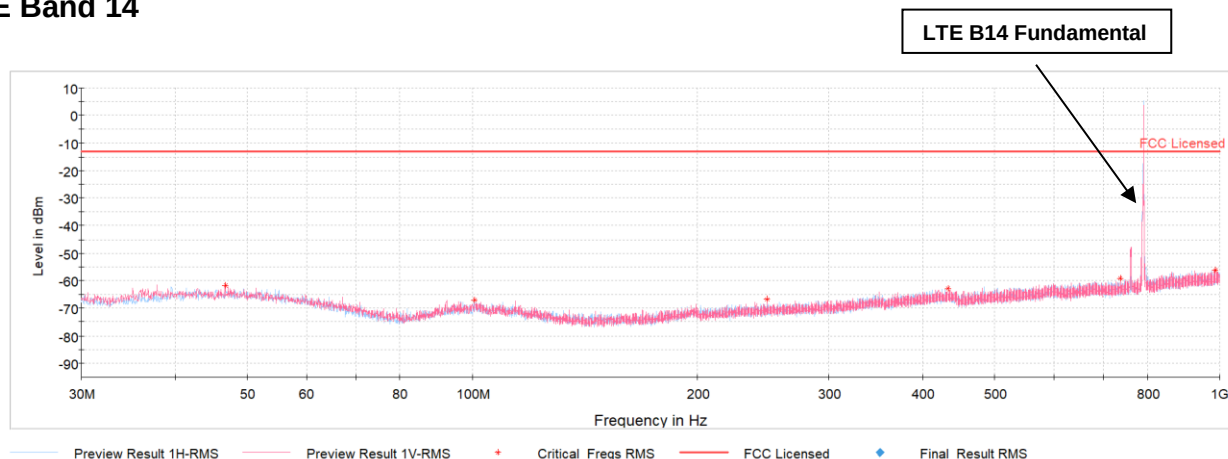
Table 7-6. Antenna BCM Radiated Spurious Data (LTE Band 26 - High Channel)

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 51 of 57

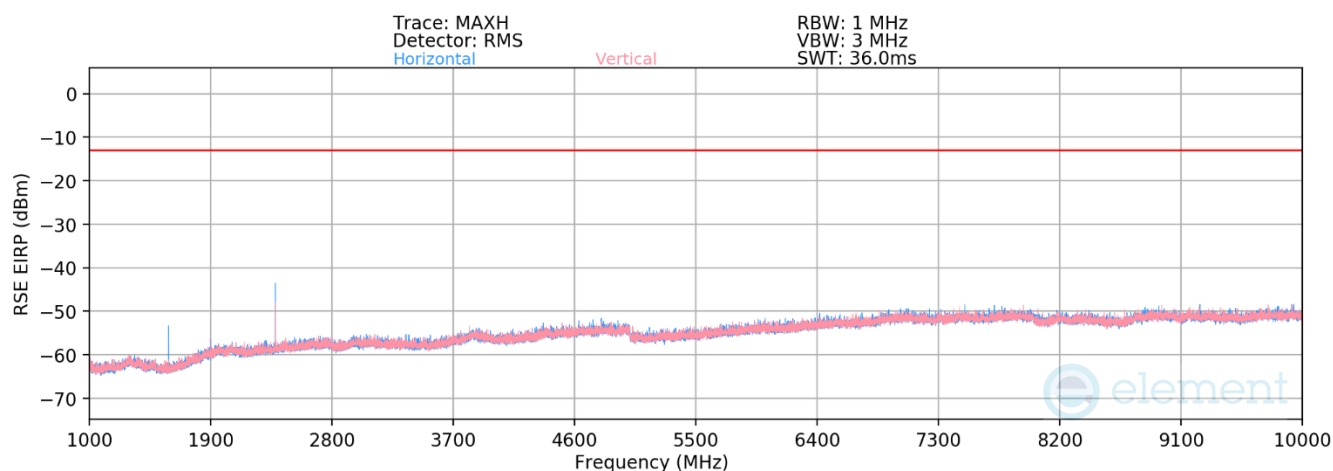
V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

LTE Band 14



Plot 7-48. Antenna BCM Radiated Spurious Plot below 1GHz (LTE Band 14)



Plot 7-49. Antenna BCM Radiated Spurious Plot above 1GHz (LTE Band 14)

FCC ID: BCG-A2984		PART 90 MEASUREMENT REPORT	Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 52 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

Bandwidth (MHz):	5
Frequency (MHz):	790.5
Modulation Signal:	QPSK
RB Config (Size / Offset):	1 / 12

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1581.0	H	132	325	-70.76	-5.07	31.17	-64.09	-40.00	-24.09
2371.5	H	109	305	-60.40	-0.26	46.34	-48.92	-13.00	-35.92
3162.0	H	-	-	-77.84	1.20	30.36	-64.89	-13.00	-51.89
3952.5	H	-	-	-78.67	2.82	31.15	-64.11	-13.00	-51.11

Table 7-7. Antenna BCM Radiated Spurious Data (LTE Band 14 - Low Channel)

Bandwidth (MHz):	10
Frequency (MHz):	793.0
Modulation Signal:	QPSK
RB Config (Size / Offset):	1 / 25

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1586.0	H	132	301	-69.33	-3.60	34.07	-61.19	-40.00	-21.19
2379.0	H	160	228	-66.88	1.49	41.61	-53.65	-13.00	-40.65
3172.0	H	-	-	-77.89	2.94	32.05	-63.20	-13.00	-50.20
3965.0	H	-	-	-78.40	4.61	33.21	-62.05	-13.00	-49.05

Table 7-8. Antenna BCM Radiated Spurious Data (LTE Band 14 - Mid Channel)

Bandwidth (MHz):	5
Frequency (MHz):	795.5
Modulation Signal:	QPSK
RB Config (Size / Offset):	1 / 12

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Analyzer Level [dBm]	AFCL [dB/m]	Field Strength [dBμV/m]	EIRP Spurious Emission Level [dBm]	Limit [dBm]	Margin [dB]
1591.0	H	167	132	-71.17	-5.04	30.79	-64.47	-40.00	-24.47
2386.5	H	271	191	-65.23	-0.23	41.54	-53.72	-13.00	-40.72
3182.0	H	-	-	-77.91	1.26	30.35	-64.91	-13.00	-51.91
3977.5	H	-	-	-78.68	2.72	31.04	-64.21	-13.00	-51.21

Table 7-9. Antenna BCM Radiated Spurious Data (LTE Band 14 - High Channel)

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 53 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

7.7 Frequency Stability / Temperature Variation

§2.1055 §90.213

Test Overview and Limit

Frequency stability testing is performed in accordance with the guidelines of ANSI C63.26-2015 and TIA-603-E-2016. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

For Band 26, the frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency. For Band 14 the frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block.

Test Procedure Used

ANSI C63.26 2015

TIA-603-E-2016

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Test Setup

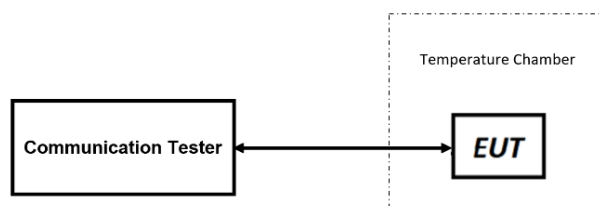


Figure 7-8. Test Instrument & Measurement Setup

Test Notes

None

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 54 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

Frequency Stability / Temperature Variation

LTE Band 26

Operating Frequency (Hz):	819,000,000
Ref. Voltage (VDC):	3.80
Deviation Limit:	± 0.00025% or 2.5 ppm

Voltage (%)	Power (VDC)	Temp (°C)	Frequency (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	- 30	819,000,002	1.62	0.0000002
		- 20	819,000,002	1.54	0.0000002
		- 10	819,000,008	8.12	0.0000010
		0	819,000,008	7.62	0.0000009
		+ 10	819,000,012	11.87	0.0000014
		+ 20 (Ref)	819,000,013	12.85	0.0000016
		+ 30	819,000,010	10.13	0.0000012
		+ 40	819,000,012	11.57	0.0000014
		+ 50	819,000,011	11.14	0.0000014
Battery Endpoint	3.40	+ 20	819,000,005	5.23	0.0000006

Table 7-10. LTE Band 26 Frequency Stability Data

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 55 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

LTE Band 14

Operating Band Lower Boundary (GHz)		0.788		
Ref. Voltage (VDC):		3.80		
Voltage (%)	Power (VDC)	Temp (°C)	Measured Freq. (GHz)	Freq. Delta from Operating Range (GHz)
100 %	3.80	- 30	0.78826	-0.0002639
		- 20	0.78826	-0.0002610
		- 10	0.78823	-0.0002308
		0	0.78823	-0.0002306
		+ 10	0.78825	-0.0002456
		+ 20 (Ref)	0.78823	-0.0002304
		+ 30	0.78824	-0.0002366
		+ 40	0.78824	-0.0002400
		+ 50	0.78824	-0.0002374
Battery Endpoint	3.40	+ 20	0.78824	-0.0002362

Table 7-11. LTE Band 14 Lower Boundary Frequency Stability Data

LTE Band 14

Operating Band Upper Boundary (GHz)		0.798		
Ref. Voltage (VDC):		3.80		
Voltage (%)	Power (VDC)	Temp (°C)	Measured Freq. (GHz)	Freq. Delta from Operating Range (GHz)
100 %	3.80	- 30	0.79773	-0.0002678
		- 20	0.79774	-0.0002620
		- 10	0.79777	-0.0002318
		0	0.79777	-0.0002328
		+ 10	0.79777	-0.0002287
		+ 20 (Ref)	0.79776	-0.0002352
		+ 30	0.79776	-0.0002354
		+ 40	0.79777	-0.0002316
		+ 50	0.79776	-0.0002366
Battery Endpoint	3.40	+ 20	0.79778	-0.0002215

Table 7-12. LTE Band 14 Upper Boundary Frequency Stability Data

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 56 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com

8.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **Apple Watch** **FCC ID: BCG-A2984** complies with all the requirements of Part 90 of the FCC rules.

FCC ID: BCG-A2984	 PART 90 MEASUREMENT REPORT		Approved by: Technical Manager
Test Report S/N: 1C2305020013-07.BCG	Test Dates: 05/05/2023 – 07/31/2023	EUT Type: Watch	Page 57 of 57

V2.1 11/9/2021

Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from Element Materials Technology Morgan Hill. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact ct.info@element.com